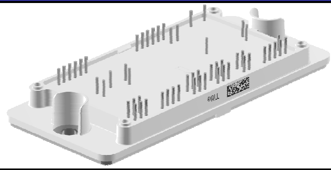
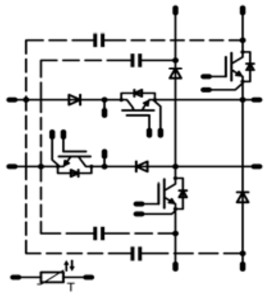
flow2 MNPC | **1200V/160A**

Features
- mixed voltage NPC topology
- reactive power capability
- low inductance layout
- Split output
- Common collector neutral connection

flow2 13mm housing


Target Applications
- solar inverter
- UPS
- Active frontend

Schematic


Types
- 30-FT12NMA160SH-M669F08

Maximum Ratings

Tj=25℃, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Half Bridge IGBT Inverse Diode				
Repetitive peak reverse voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j=T_j$max T_h=80℃ T_c=80℃	17 22	A
Maximum repetitive forward current	I_{FRM}	tp=10ms	14	A
I^2t-value	I^2t	$T_j=T_j$max	40	A^2s
Power dissipation per Diode	P_{tot}	T_h=80℃ T_c=80℃	40 60	W
Maximum Junction Temperature	T_{jmax}		150	℃
Half Bridge IGBT				
Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j=T_j$max T_h=80℃ T_c=80℃	157 202	A
Pulsed collector current	I_{Cpulse}	t_p limited by $T_j$max	480	A
Turn off safe operating area		V_{CEmax} = 1200V, T_{vj} ≤ 150℃	320	A
Power dissipation per IGBT	P_{tot}	$T_j=T_j$max T_h=80℃ T_c=80℃	398 604	W
Gate-emitter peak voltage	V_{GE}		±20	V
Short circuit ratings	t_{SC} V_{CC}	T_j≤150℃ V_{GE}=15V	10 800	µs V
Maximum Junction Temperature	$T_j$max		175	℃

Maximum Ratings

Tj=25℃, unless otherwise specified

Parameter	Symbol	Condition		Value	Unit
Neutral Point FWD					
Peak Repetitive Reverse Voltage	V_{RRM}			600	V
DC forward current	I_F	T_j=$T_j$max	T_h=80℃ T_c=80℃	96 129	A
Non-repetitive Peak Surge Current	I_{FSM}	t_p limited by $T_j$max		1200	A
Power dissipation per Diode	P_{tot}	T_j=$T_j$max	T_h=80℃ T_c=80℃	110 166	W
Maximum Junction Temperature	$T_j$max			150	℃
Neutral Point IGBT					
Collector-emitter break down voltage	V_{CE}			600	V
DC collector current	I_C	T_j=$T_j$max	T_h=80℃ T_c=80℃	91 121	A
Pulsed collector current	I_{cpulse}	t_p limited by $T_j$max		300	A
Turn off safe operating area		V_{CE} ≤ 600V, T_j ≤ 175℃		300	A
Power dissipation per IGBT	P_{tot}	T_j=$T_j$max	T_h=80℃ T_c=80℃	174 264	W
Gate-emitter peak voltage	V_{GE}			±20	V
Short circuit ratings	t_{SC} V_{CC}	T_j≤150℃ V_{GE}=15V		6 360	µs V
Maximum Junction Temperature	$T_j$max			175	℃
Neutral Point Inverse Diode					
Peak Repetitive Reverse Voltage	V_{RRM}			600	V
DC forward current	I_F	T_j=$T_j$max	T_h=80℃ T_c=80℃	38 51	A
Maximum repetitive forward current	I_{FRM}	t_p limited by $T_j$max		60	A
Power dissipation per Diode	P_{tot}	T_j=$T_j$max	T_h=80℃ T_c=80℃	65 99	W
Maximum Junction Temperature	$T_j$max			175	℃
Half Bridge FWD					
Peak Repetitive Reverse Voltage	V_{RRM}			1200	V
DC forward current	I_F	T_j=$T_j$max	T_h=80℃ T_c=80℃	50 66	A
Nonrepetitive peak surge current	I_{FRM}	t_p limited by $T_j$max (Halfwave 1 Phase 60Hz)		650	A
Power dissipation per Diode	P_{tot}	T_j=$T_j$max	T_h=80℃ T_c=80℃	94 143	W
Maximum Junction Temperature	$T_j$max			150	℃

Maximum Ratings

Tj=25℃, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Thermal Properties				
Storage temperature	T_{stg}		-40…+125	℃
Operation temperature under switching condition	T_{op}		-40…+(Tjmax - 25)	℃
Insulation Properties				
Insulation voltage	V_{is}	t=2s DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm
Comparative tracking index	CTI		>200	

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_C [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max	
Half Bridge IGBT Inverse Diode										
Forward voltage	V_f				7	Tj=25℃ Tj=125℃	1	1,97 1,65	3,4	V
Threshold voltage (for power loss calc. only)	V_{to}				7	Tj=25℃ Tj=125℃		1,33 1,01		V
Slope resistance (for power loss calc. only)	r_t				7	Tj=25℃ Tj=125℃		91 91		mΩ
Reverse current	I_r			1200		Tj=25℃ Tj=125℃			0,25	mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						1,77		K/W
Thermal resistance chip to case per chip	R_{thJC}							1,17		
Halfbridge IGBT										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,006	Tj=25℃ Tj=125℃	5,2	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		160	Tj=25℃ Tj=125℃	2	2,02 2,37	2,4	V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	1200		Tj=25℃ Tj=125℃			0,02	mA
Gate-emitter leakage current	I_{GES}		20	0		Tj=25℃ Tj=125℃			480	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(ON)}$	Rgoff=4 Ω Rgon=4 Ω	±15	350	100	Tj=25℃ Tj=125℃		133 135		ns
Rise time	t_r					Tj=25℃ Tj=125℃		20 23		
Turn-off delay time	$t_{d(OFF)}$					Tj=25℃ Tj=125℃		225 276		
Fall time	t_f					Tj=25℃ Tj=125℃		38 64		
Turn-on energy loss per pulse	E_{on}					Tj=25℃ Tj=125℃		1,80 3,18		mWs
Turn-off energy loss per pulse	E_{off}					Tj=25℃ Tj=125℃		2,52 4,03		
Input capacitance	C_{ies}	f=1MHz	0	25		Tj=25℃		9200		pF
Output capacitance	C_{oss}							920		
Reverse transfer capacitance	C_{rss}							540		
Gate charge	Q_{Gate}		15	960	160			740		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,24		K/W
Thermal resistance chip to case per chip	R_{thJC}							0,16		
Neutral Point FWD										
Diode forward voltage	V_F				120	Tj=25℃ Tj=125℃		1,47 1,29	1,7	V
Peak reverse recovery current	I_{RRM}	Rgon=4 Ω	±15	350	100	Tj=25℃ Tj=125℃		127 151		A
Reverse recovery time	t_{rr}					Tj=25℃ Tj=125℃		40 81		ns
Reverse recovered charge	Q_{rr}					Tj=25℃ Tj=125℃		3,02 7,13		μC
Peak rate of fall of recovery current	di(rec)max /dt					Tj=25℃ Tj=125℃		12386 3767		A/μs
Reverse recovered energy	Erec					Tj=25℃ Tj=125℃		0,31 1,01		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,64		K/W
Thermal resistance chip to case per chip	R_{thJC}							0,42		
Neutral Point IGBT										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,0016	Tj=25℃ Tj=125℃	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		100	Tj=25℃ Tj=125℃	1,05	1,58 1,8	1,85	V
Collector-emitter cut-off incl diode	I_{CES}		0	600		Tj=25℃ Tj=125℃			0,0052	mA
Gate-emitter leakage current	I_{GES}		20	0		Tj=25℃ Tj=125℃			1200	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$	Rgoff=4 Ω Rgon=4 Ω	±15	350	100	Tj=25℃ Tj=125℃		103 103		ns
Rise time	t_r					Tj=25℃ Tj=125℃		17 19		
Turn-off delay time	$t_{d(off)}$					Tj=25℃ Tj=125℃		158 179		
Fall time	t_f					Tj=25℃ Tj=125℃		44 64		
Turn-on energy loss per pulse	E_{on}					Tj=25℃ Tj=125℃		1,06 1,52		μWs
Turn-off energy loss per pulse	E_{off}					Tj=25℃ Tj=125℃		2,48 3,32		
Input capacitance	C_{ies}	f=1MHz	0	25		Tj=25℃		6280		pF
Output capacitance	C_{oss}							400		
Reverse transfer capacitance	C_{rss}							186		
Gate charge	Q_{Gate}		15	480	100			620		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,54		K/W
Thermal resistance chip to case per chip	R_{thJC}							0,36		

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
			V_{GE} [V] or V_{GS} [V]	V_r [V] or V_{CE} [V] or V_{DS} [V]	I_C [A] or I_F [A] or I_D [A]	T_j	Min	Typ	Max	
Neutral Point Inverse Diode										
Diode forward voltage	V_F				30	Tj=25°C Tj=125°C	1,00	1,64 1,55	1,95	V
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						1,45		K/W
Coupled thermal resistance inverter transistor-diode	R_{thJC}							0,96		
Half Bridge FWD										
Diode forward voltage	V_F				60	Tj=25°C Tj=125°C	1,50	2,47 2,11	3,30	V
Reverse leakage current	I_r			1200		Tj=25°C Tj=125°C			200	μA
Peak reverse recovery current	I_{RRM}	Rgon=4 Ω	±15	350	100	Tj=25°C Tj=125°C		107 142		A
Reverse recovery time	t_{rr}					Tj=25°C Tj=125°C		51 69		ns
Reverse recovered charge	Q_{rr}					Tj=25°C Tj=125°C		6 13		μC
Peak rate of fall of recovery current	di(rec)max /dt					Tj=25°C Tj=125°C		5985 2890		A/μs
Reverse recovery energy	E_{rec}					Tj=25°C Tj=125°C		1,71 3,61		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,74		K/W
Thermal resistance chip to case per chip	R_{thJC}							0,49		
Thermistor										
Rated resistance	R					Tj=25°C		22000		Ω
Deviation of R25	ΔR/R	R100=1486 Ω				Tj=100°C	-5		+5	%
Power dissipation	P					Tj=25°C		200		mW
Power dissipation constant						Tj=25°C		2		mW/K
B-value	$B_{(25/50)}$	Tol. ±3%				Tj=25°C		3950		K
B-value	$B_{(25/100)}$	Tol. ±3%				Tj=25°C		3998		K
Vincotech NTC Reference									B	

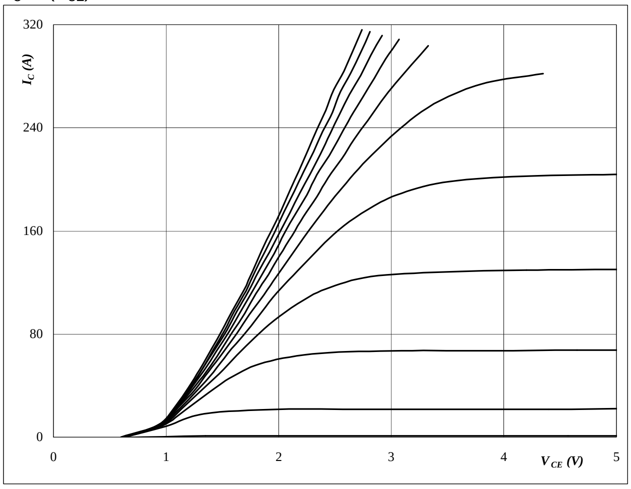
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 1 IGBT

Typical output characteristics

$I_C = f(V_{CE})$



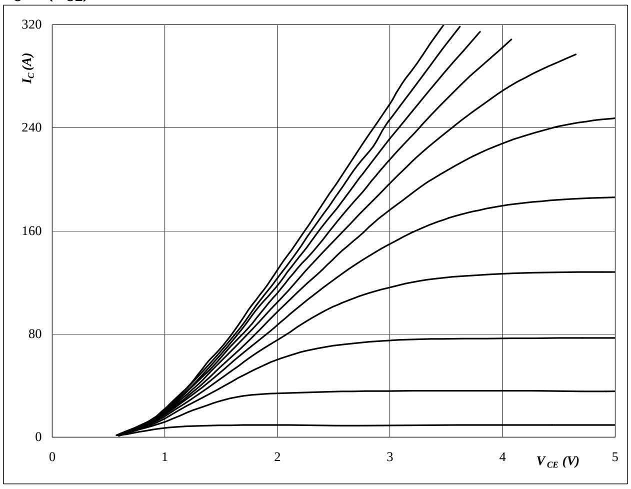
At

t_p =	250	µs
T_j =	25	℃
V_{GE} from	7 V to 17 V in steps of 1 V	

Figure 2 IGBT

Typical output characteristics

$I_C = f(V_{CE})$



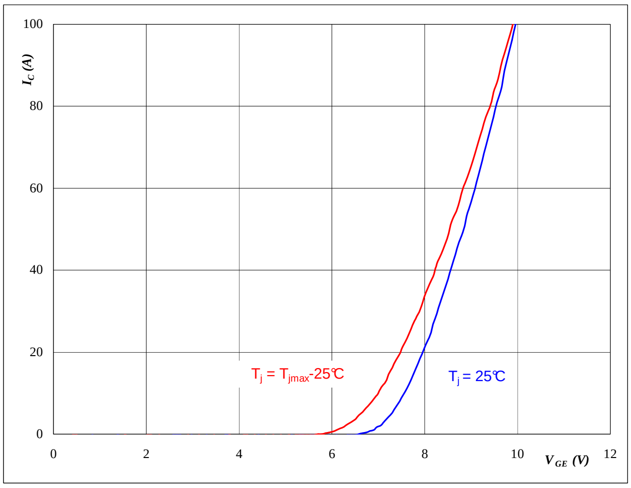
At

t_p =	250	µs
T_j =	125	℃
V_{GE} from	7 V to 17 V in steps of 1 V	

Figure 3 IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$



At

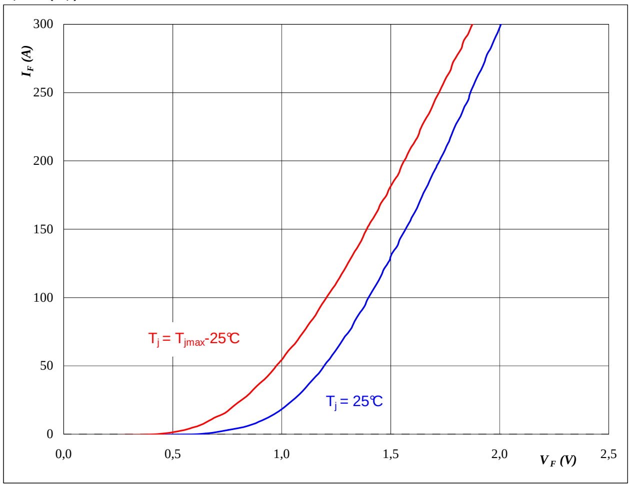
t_p =	250	µs
V_{CE} =	10	V
T_j =	25/150	℃

Figure 4 NP FWD

Typical FWD forward current as

a function of forward voltage

$I_F = f(V_F)$



At

t_p =	250	µs
T_j =	25/150	℃

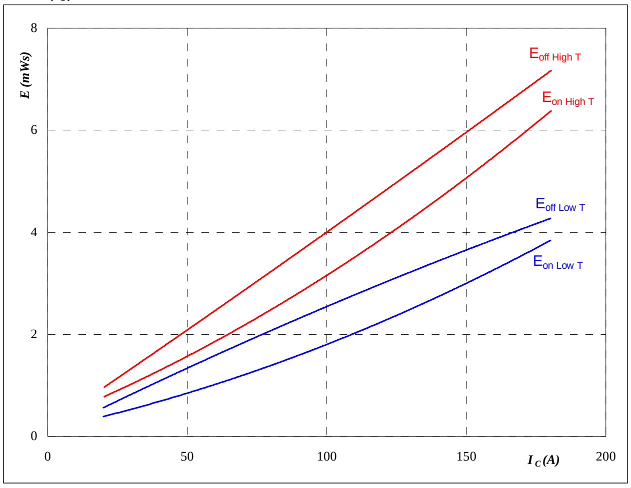
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 5 IGBT

Typical switching energy losses as a function of collector current

E = f(I_C)



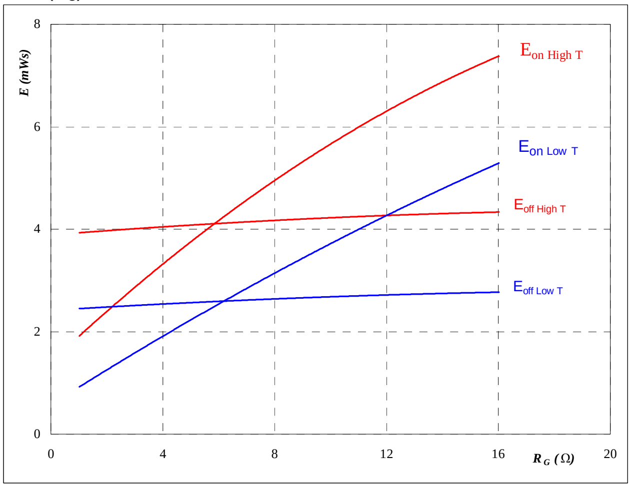
With an inductive load at

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Figure 6 IGBT

Typical switching energy losses as a function of gate resistor

E = f(R_G)



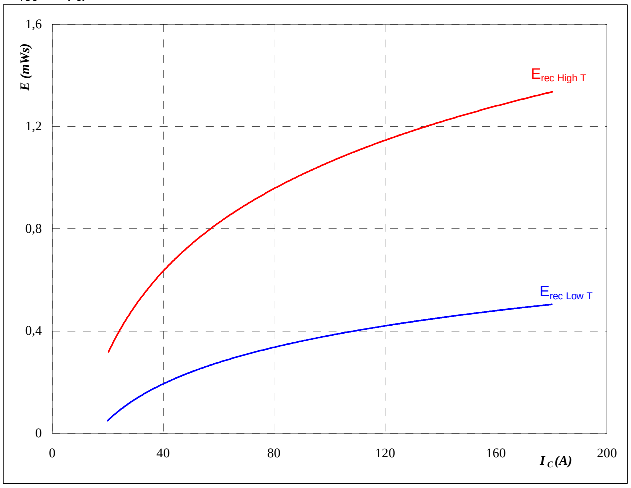
With an inductive load at

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

Figure 7 NP FWD

Typical reverse recovery energy loss as a function of collector current

E_{rec} = f(I_c)



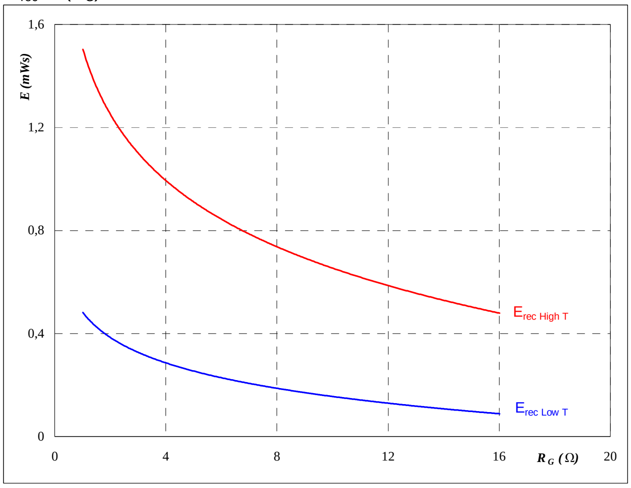
With an inductive load at

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 8 NP FWD

Typical reverse recovery energy loss as a function of gate resistor

E_{rec} = f(R_G)



With an inductive load at

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

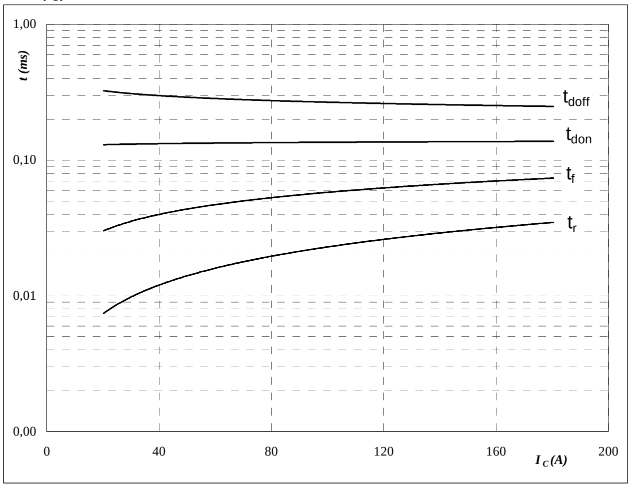
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 9	IGBT

Typical switching times as a function of collector current

t = f(I_C)



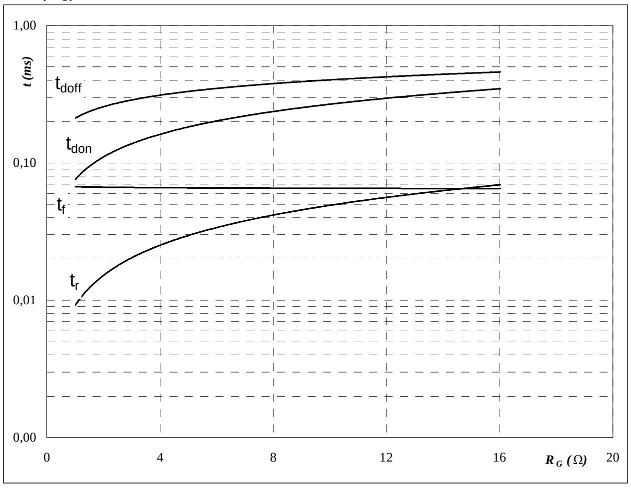
With an inductive load at

T_j =	125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Figure 10	IGBT

Typical switching times as a function of gate resistor

t = f(R_G)



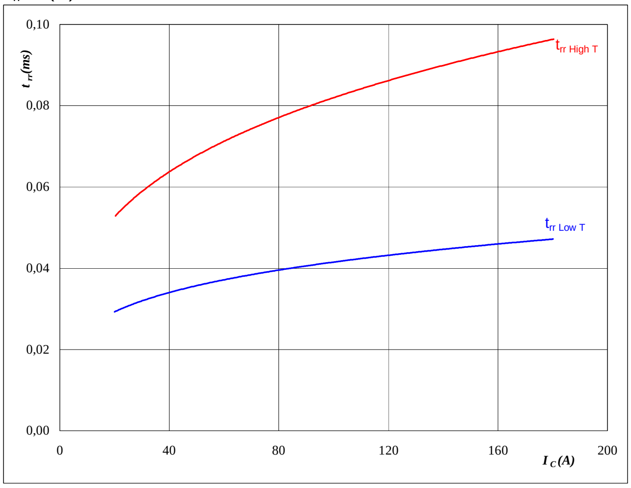
With an inductive load at

T_j =	125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

Figure 11	NP FWD

Typical reverse recovery time as a function of collector current

t_{rr} = f(Ic)



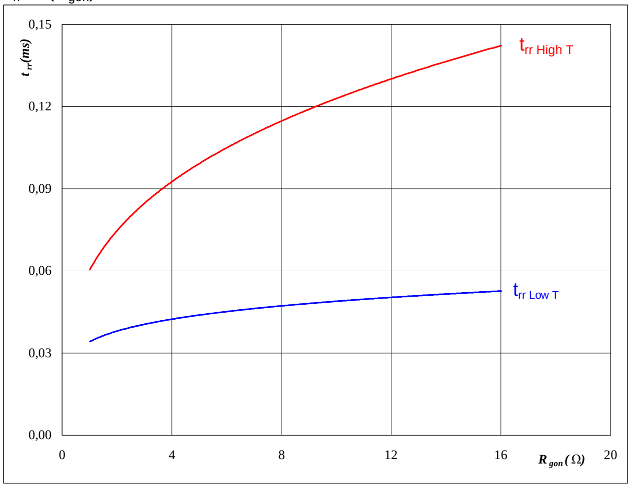
At

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 12	NP FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

t_{rr} = f(R_{gon})



At

T_j =	25/125	°C
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

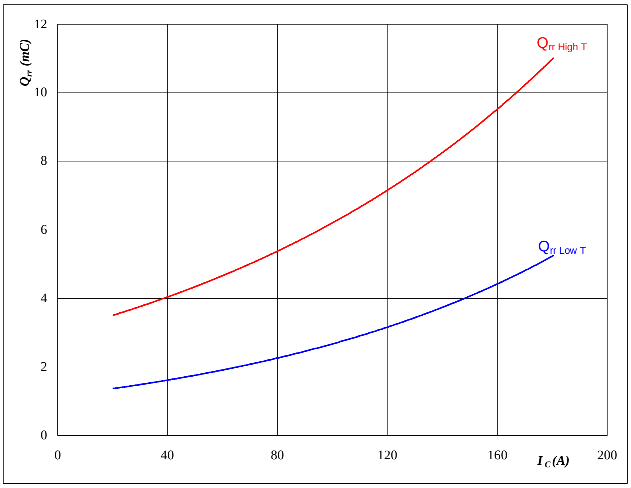
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 13 NP FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$



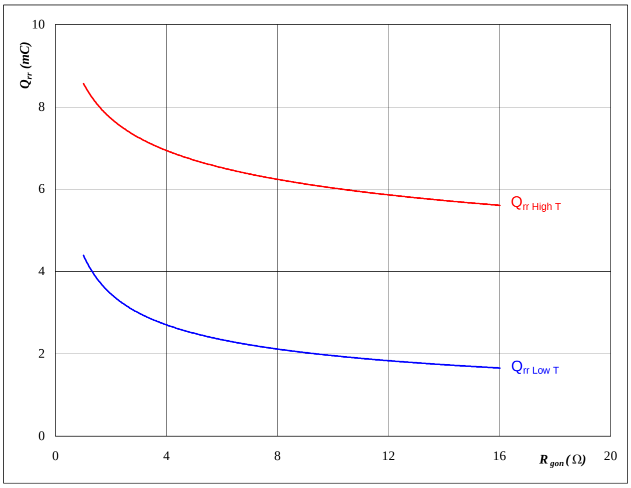
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 14 NP FWD

Typical reverse recovery charge as a function of JFET turn on gate resistor

$Q_{rr} = f(R_{gon})$



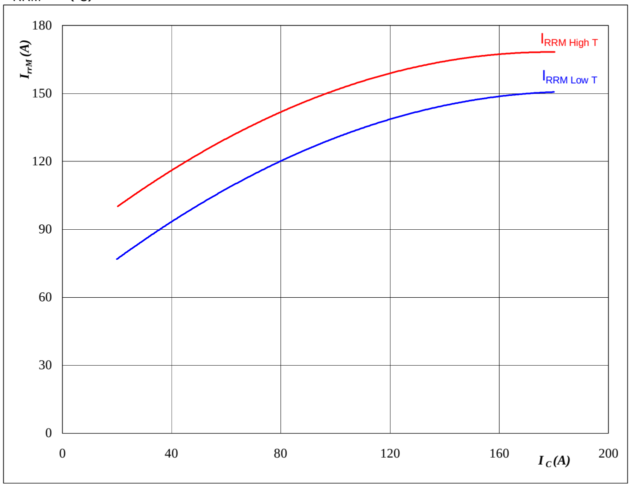
At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

Figure 15 NP FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$



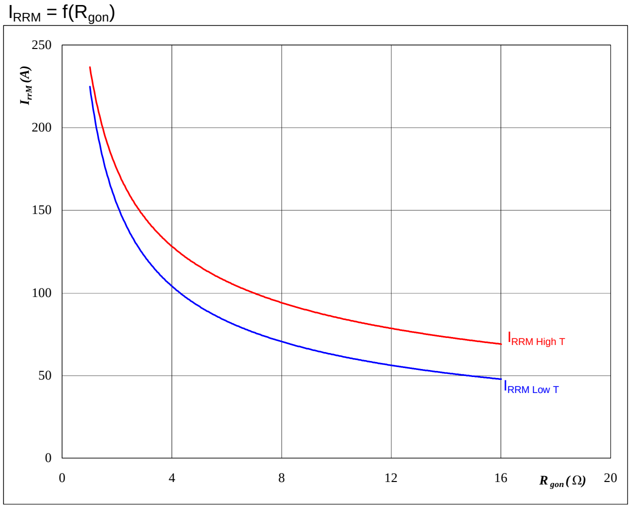
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 16 NP FWD

Typical reverse recovery current as a function of JFET turn on gate resistor

$I_{RRM} = f(R_{gon})$



At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

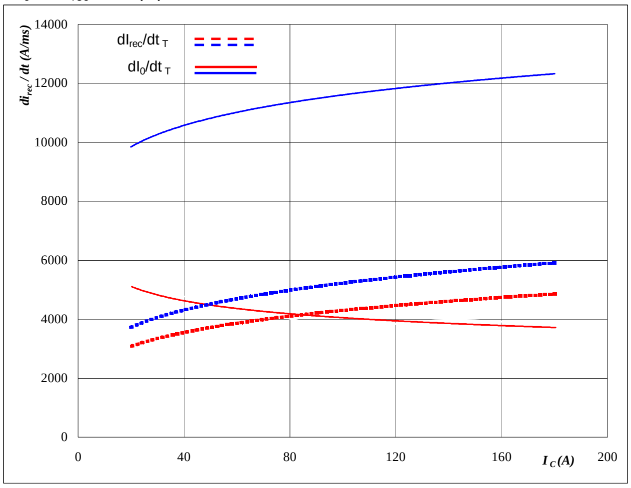
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 17 NP FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$dI_0/dt, dI_{rec}/dt = f(I_c)$



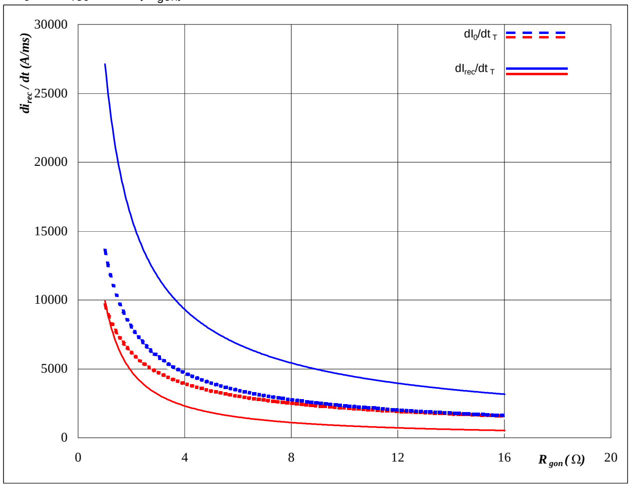
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 18 NP FWD

Typical rate of fall of forward and reverse recovery current as a function of JFET turn on gate resistor

$dI_0/dt, dI_{rec}/dt = f(R_{gon})$



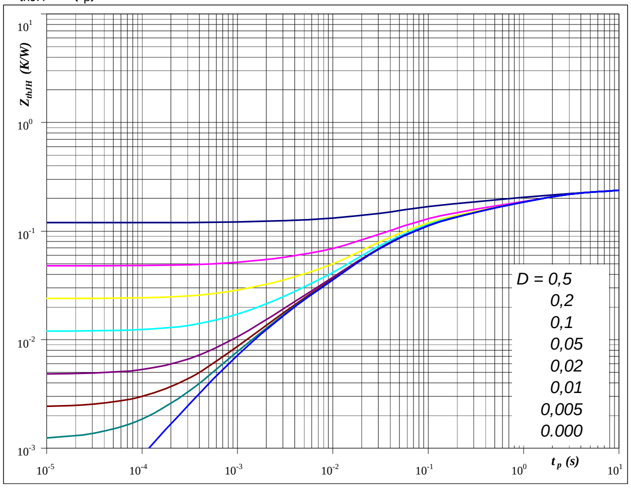
At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

Figure 19 IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

D =	t_p / T	
R_{thJH} =	0,24	K/W

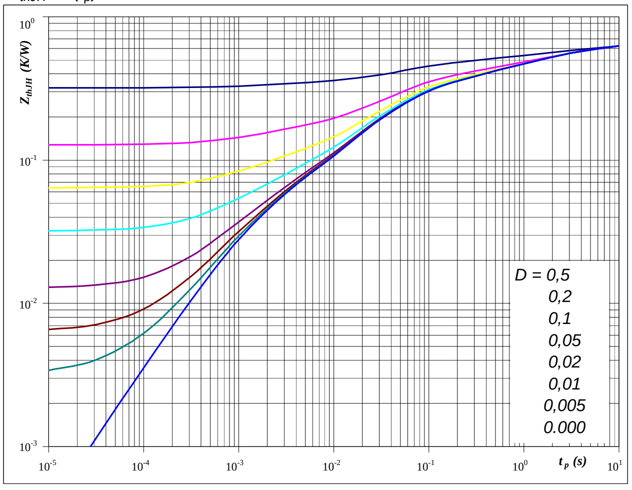
IGBT thermal model values

R (C/W)	Tau (s)
0,08	2,26
0,06	0,29
0,07	0,05
0,02	0,01
0,01	0,002

Figure 20 NP FWD

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

D =	t_p / T	
R_{thJH} =	0,64	K/W

FWD thermal model values

R (C/W)	Tau (s)
0,17	3,90
0,11	0,85
0,08	0,18
0,20	0,04
0,04	0,01
0,03	0,001

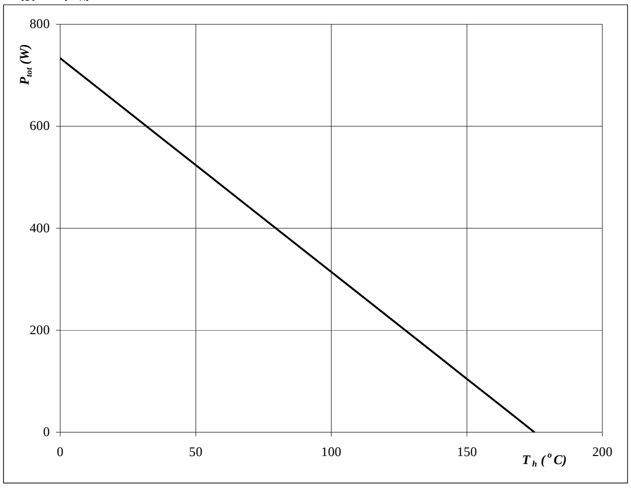
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 21 IGBT

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



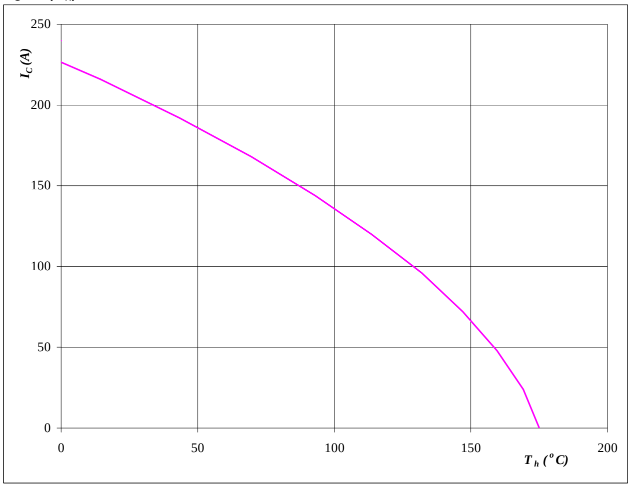
At

T_j = 175 ℃

Figure 22 IGBT

Collector current as a function of heatsink temperature

$I_C = f(T_h)$



At

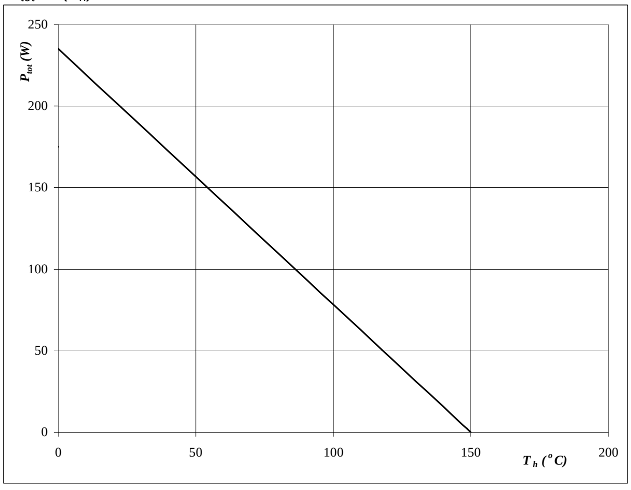
T_j = 175 ℃

V_{GE} = 15 V

Figure 23 NP FWD

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



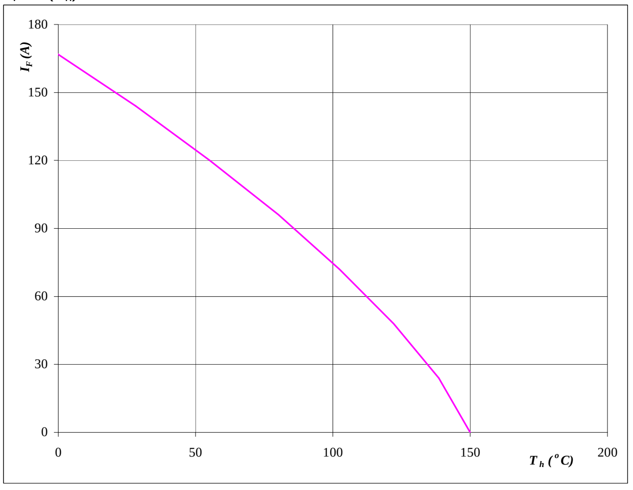
At

T_j = 150 ℃

Figure 24 NP FWD

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At

T_j = 150 ℃

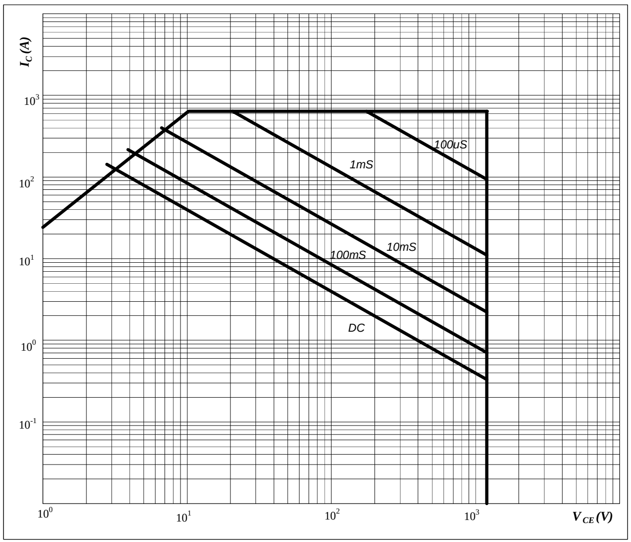
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 25 IGBT

Safe operating area as a function of collector-emitter voltage

$I_C = f(V_{CE})$



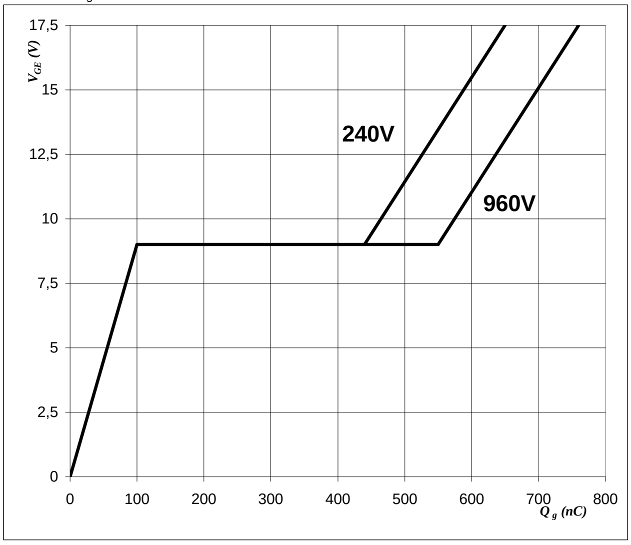
At

D =	single pulse	
Th =	80	ºC
V_{GE} =	±15	V
T_j =	T_{jmax}	ºC

Figure 26 IGBT

Gate voltage vs Gate charge

$V_{GE} = f(Q_g)$



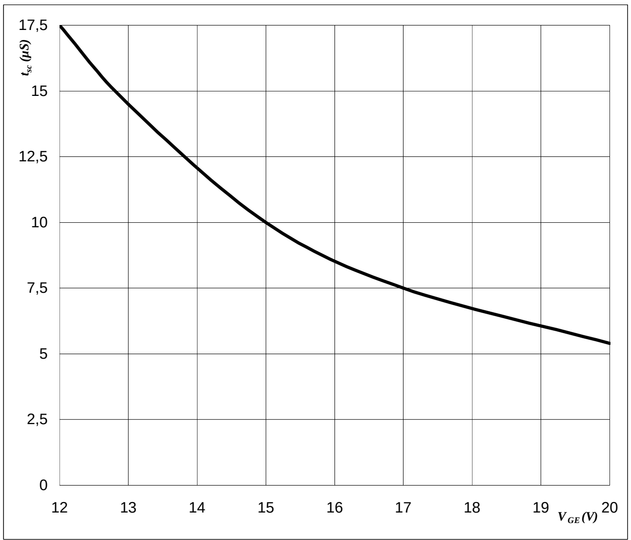
At

I_D =	160	A
T_j=	25	ºC

Figure 27 Output inverter IGBT

Short circuit withstand time as a function of gate-emitter voltage

$t_{sc} = f(V_{GE})$



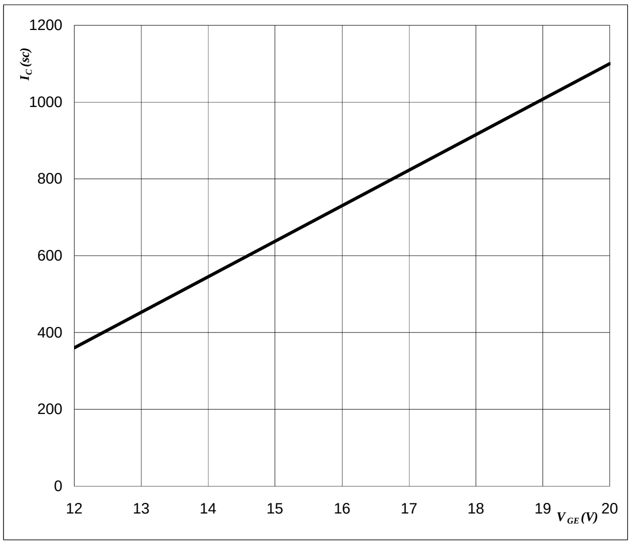
At

V_{CE} =	1200	V
T_j ≤	175	ºC

Figure 28 Output inverter IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$V_{GE} = f(Q_{GE})$



At

V_{CE} ≤	1200	V
T_j =	175	ºC

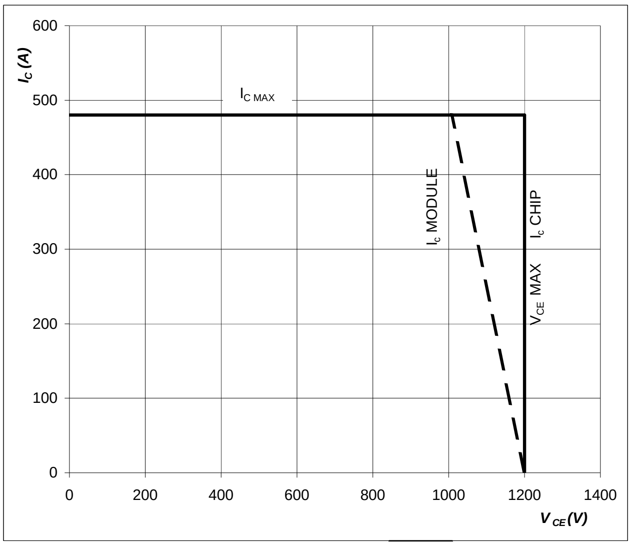
Half Bridge

Half Bridge IGBT and Neutral Point FWD

Figure 27 IGBT

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j = T_{jmax}-25 ºC

$U_{ccminus}$=U_{ccplus}

Switching mode : 3 level switching

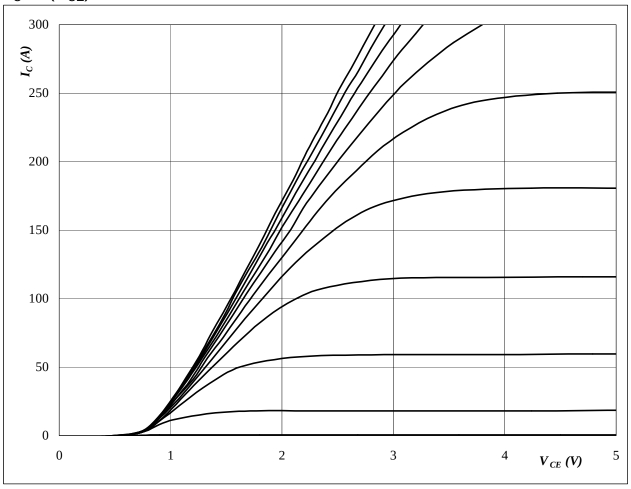
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 1 NP IGBT

Typical output characteristics

$I_C = f(V_{CE})$



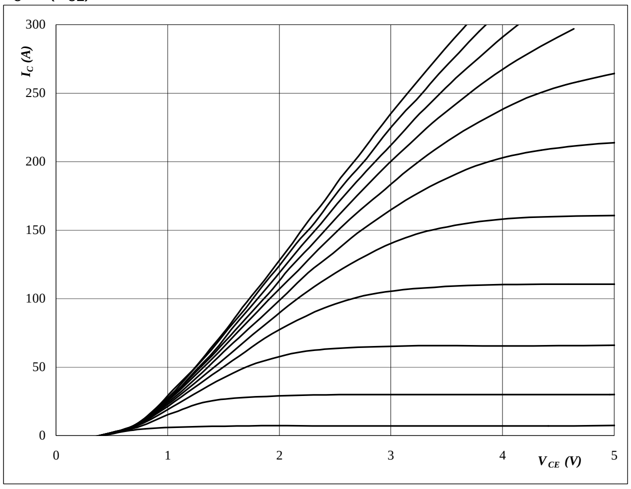
At

t_p =	250	μs
T_j =	25	℃
V_{GE} from	7 V to 17 V in steps of 1 V	

Figure 2 NP IGBT

Typical output characteristics

$I_C = f(V_{CE})$



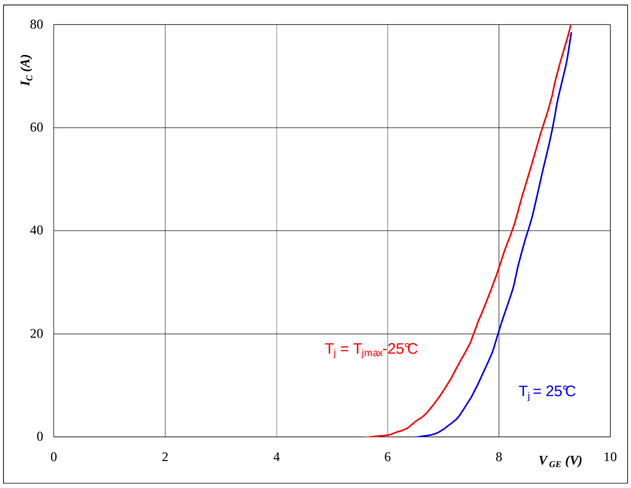
At

t_p =	250	μs
T_j =	150	℃
V_{GE} from	7 V to 17 V in steps of 1 V	

Figure 3 NP IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$



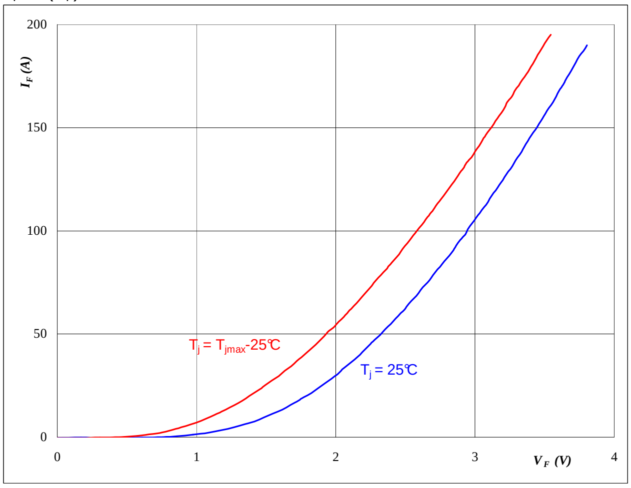
At

t_p =	250	μs
V_{CE} =	10	V
T_j =	25/150	℃

Figure 4 FWD

Typical FWD forward current as a function of forward voltage

$I_F = f(V_F)$



At

t_p =	250	μs
T_j =	25/150	℃

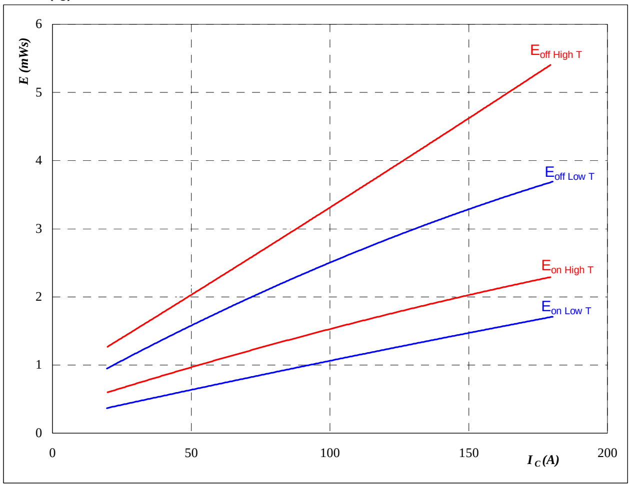
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 5 NP IGBT

Typical switching energy losses as a function of collector current

E = f(I_C)



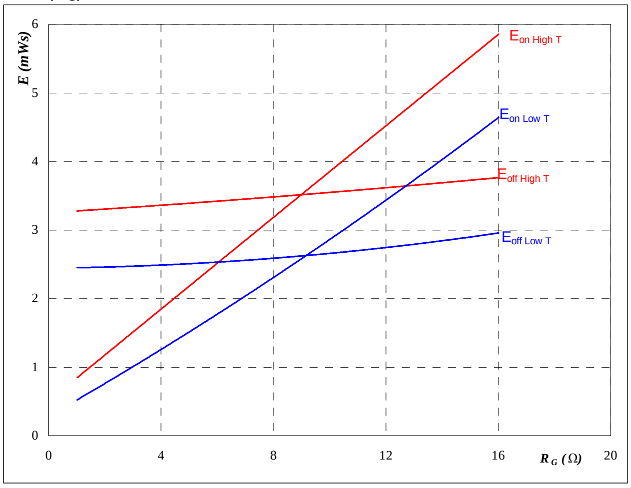
With an inductive load at

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Figure 6 NP IGBT

Typical switching energy losses as a function of gate resistor

E = f(R_G)



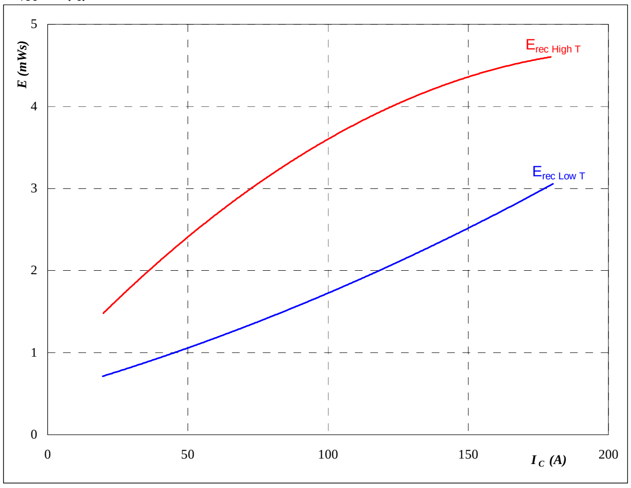
With an inductive load at

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

Figure 7 FWD

Typical reverse recovery energy loss as a function of collector current

E_{rec} = f(I_c)



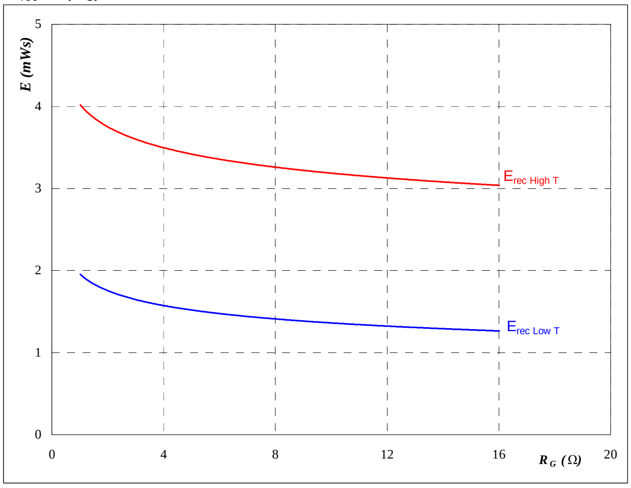
With an inductive load at

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 8 FWD

Typical reverse recovery energy loss as a function of gate resistor

E_{rec} = f(R_G)



With an inductive load at

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

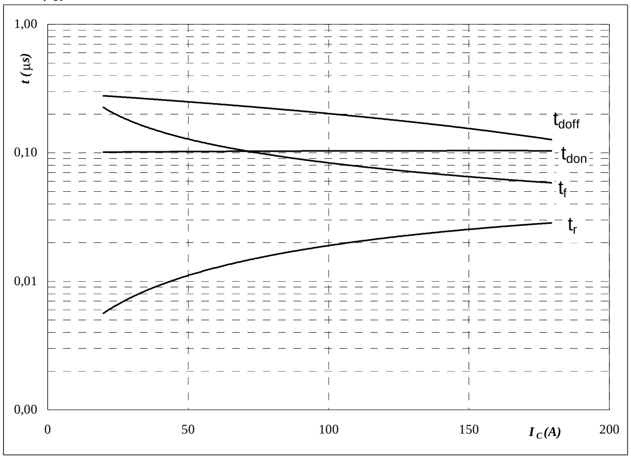
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 9 NP IGBT

Typical switching times as a function of collector current

t = f(I_C)



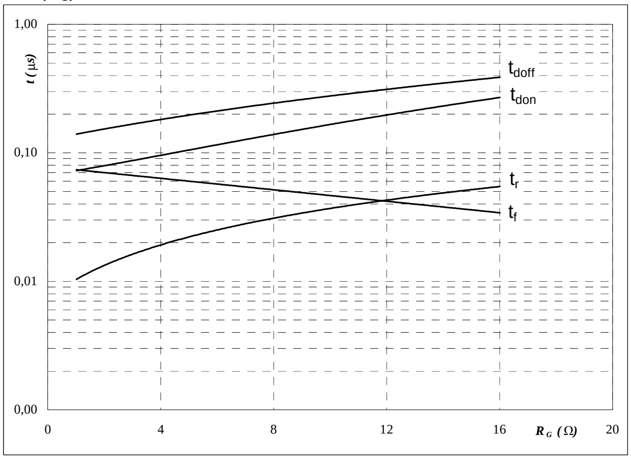
With an inductive load at

T_j =	125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω
R_{goff} =	4	Ω

Figure 10 NP IGBT

Typical switching times as a function of gate resistor

t = f(R_G)



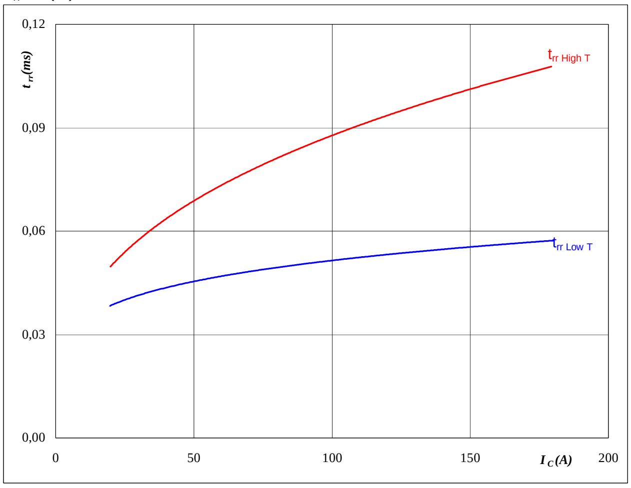
With an inductive load at

T_j =	125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
I_C =	100	A

Figure 11 FWD

Typical reverse recovery time as a function of collector current

t_{rr} = f(Ic)



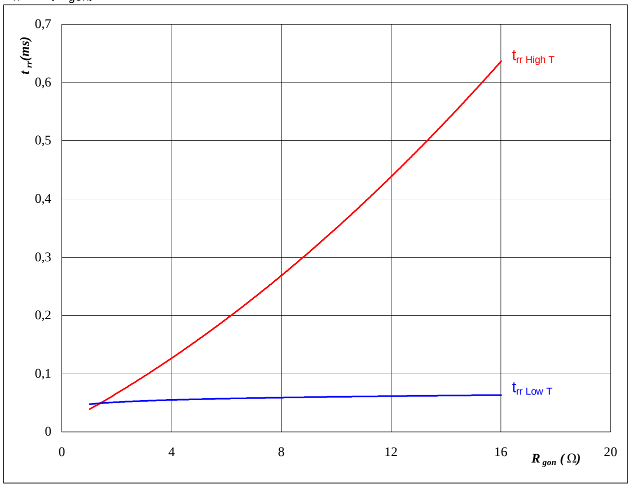
At

T_j =	25/125	°C
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4,0	Ω

Figure 12 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

t_{rr} = f(R_{gon})



At

T_j =	25/125	°C
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

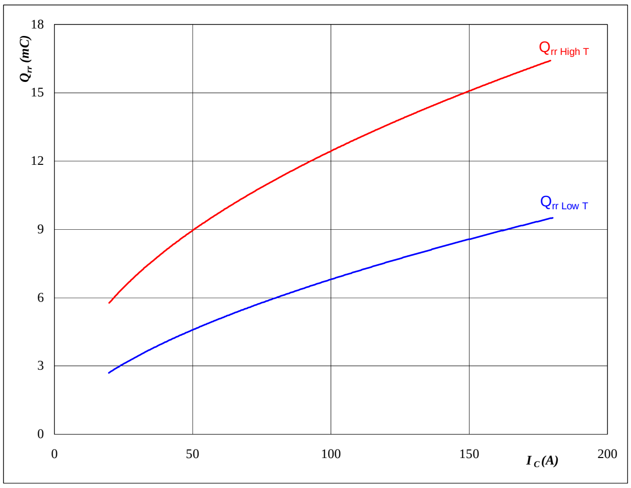
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 13 FWD

Typical reverse recovery charge as a function of collector current

$Q_{rr} = f(I_C)$



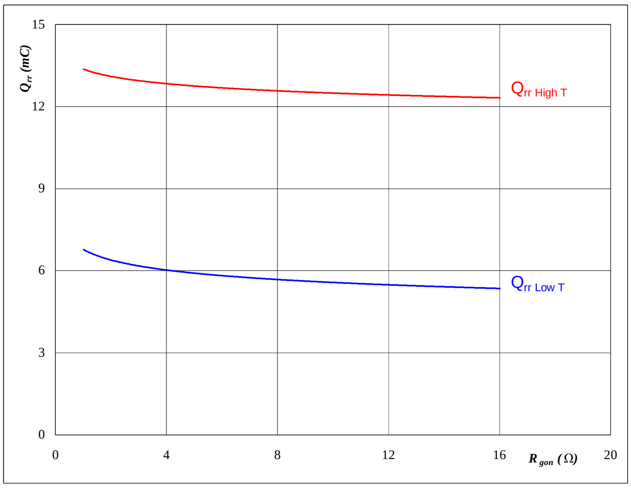
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 14 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$Q_{rr} = f(R_{gon})$



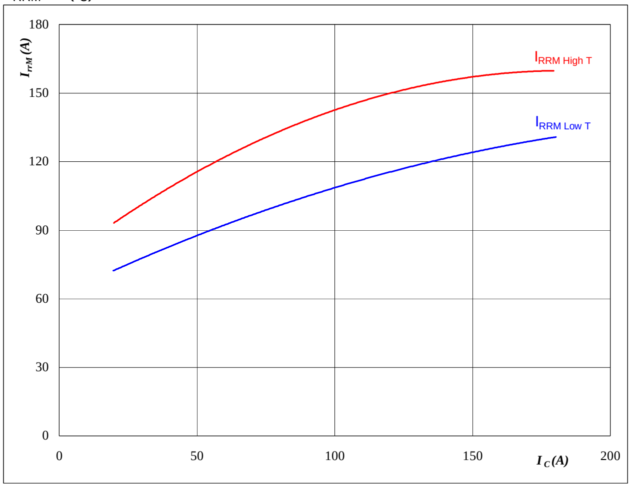
At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

Figure 15 FWD

Typical reverse recovery current as a function of collector current

$I_{RRM} = f(I_C)$



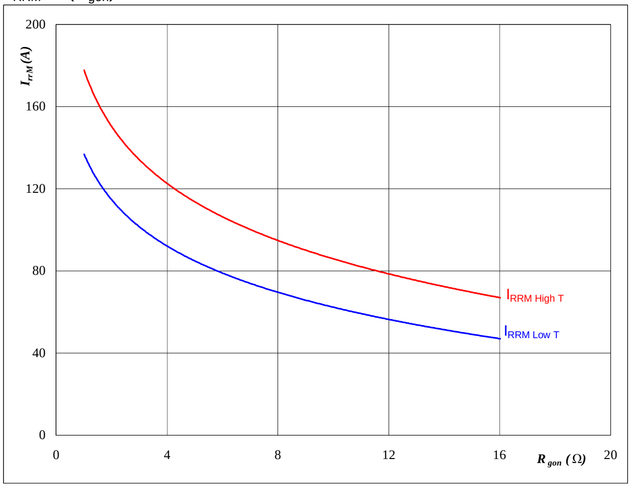
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 16 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$I_{RRM} = f(R_{gon})$



At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

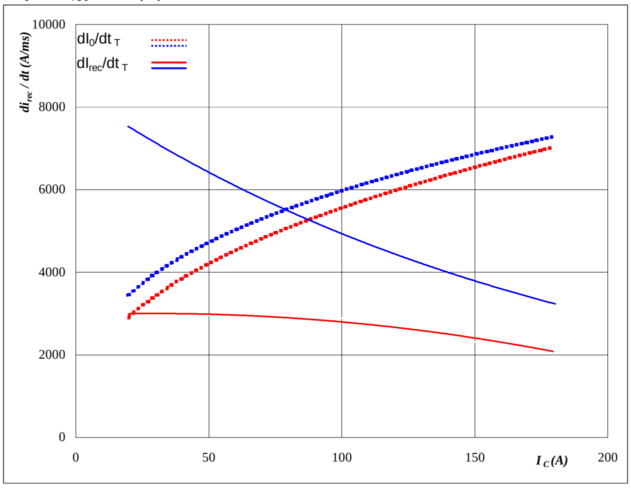
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 17 FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$dI_0/dt, dI_{rec}/dt = f(I_c)$



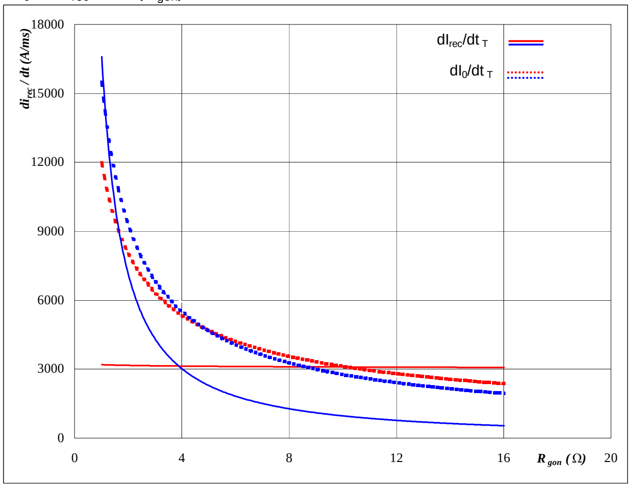
At

T_j =	25/125	℃
V_{CE} =	350	V
V_{GE} =	±15	V
R_{gon} =	4	Ω

Figure 18 FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$dI_0/dt, dI_{rec}/dt = f(R_{gon})$



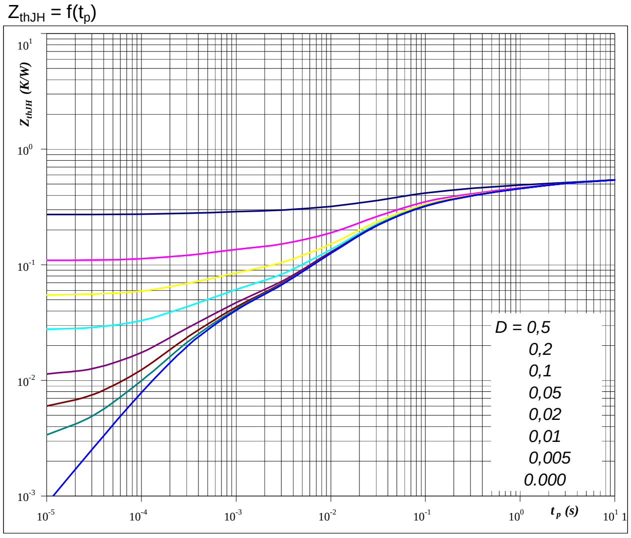
At

T_j =	25/125	℃
V_R =	350	V
I_F =	100	A
V_{GE} =	±15	V

Figure 19 NP IGBT

IGBT transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

D =	tp / T	
R_{thJH} =	0,54	K/W

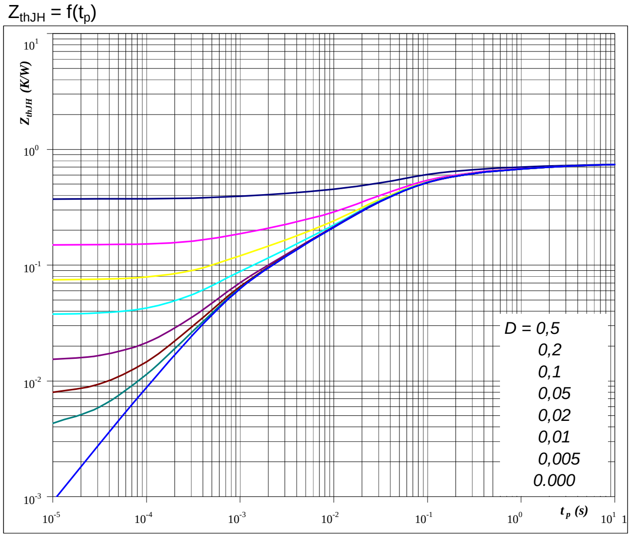
IGBT thermal model values

R (C/W)	Tau (s)
0,11	2,87
0,09	0,46
0,12	0,10
0,17	0,02
0,03	0,004

Figure 20 FWD

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

D =	tp / T	
R_{thJH} =	0,74	K/W

FWD thermal model values

R (C/W)	Tau (s)
0,07	3,67
0,10	0,54
0,20	0,10
0,26	0,03
0,07	0,005

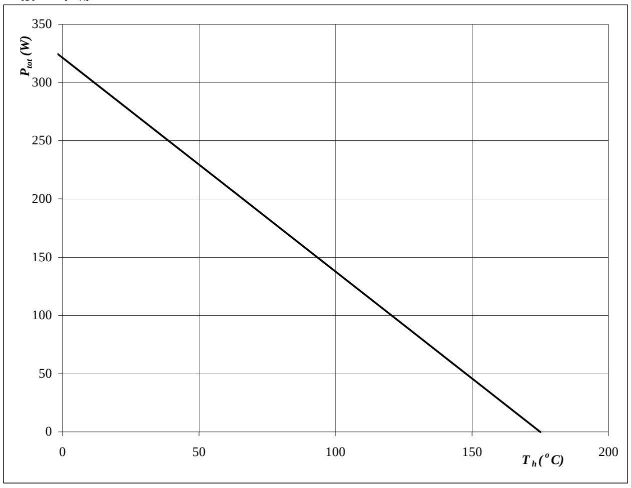
Neutral Point IGBT

Neutral Point IGBT and Half Bridge FWD

Figure 21	NP IGBT

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



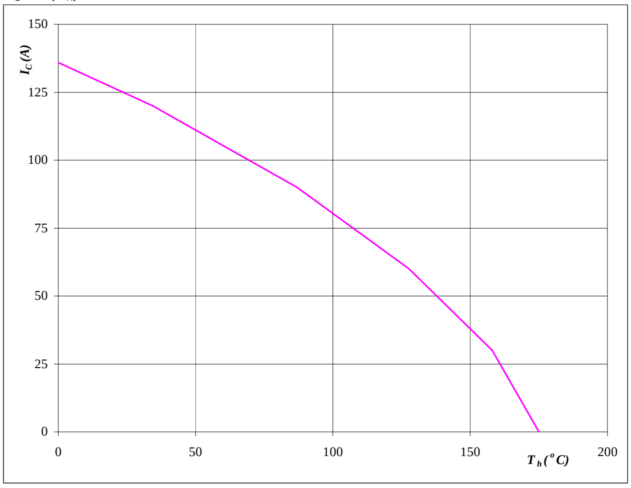
At

T_j = 175 ºC

Figure 22	NP IGBT

Collector current as a function of heatsink temperature

$I_C = f(T_h)$



At

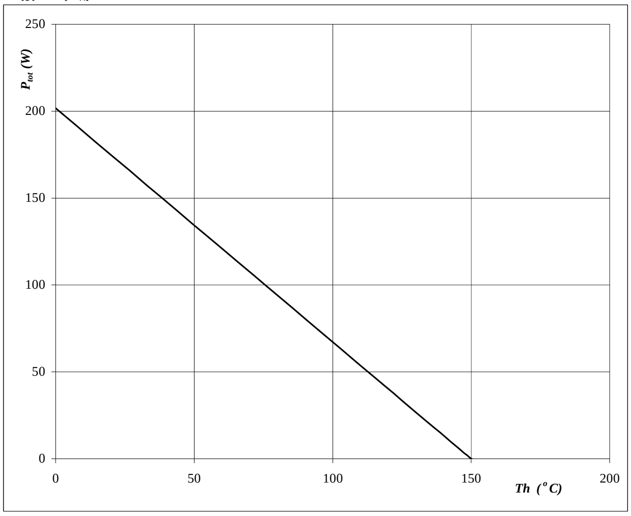
T_j = 175 ºC

V_{GE} = 15 V

Figure 23	FWD

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



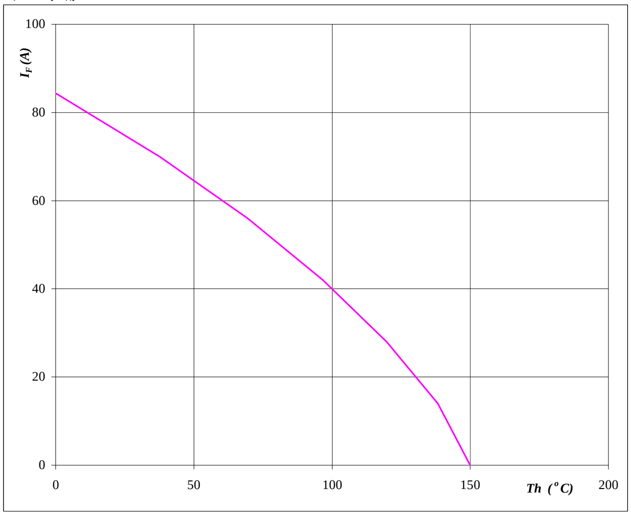
At

T_j = 150 ºC

Figure 24	FWD

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At

T_j = 150 ºC

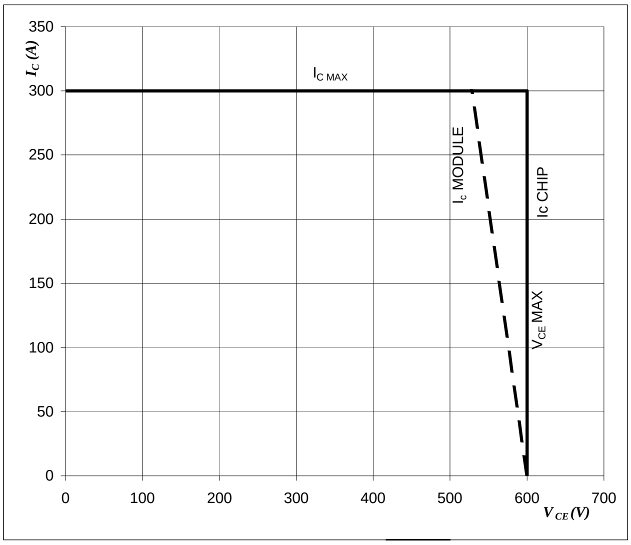
Neutral Point IGBT

Neutral Point IGBT

Figure 25 NP IGBT

Reverse bias safe operating area

$I_C = f(V_{CE})$



At

T_j = T_{jmax}-25 ºC

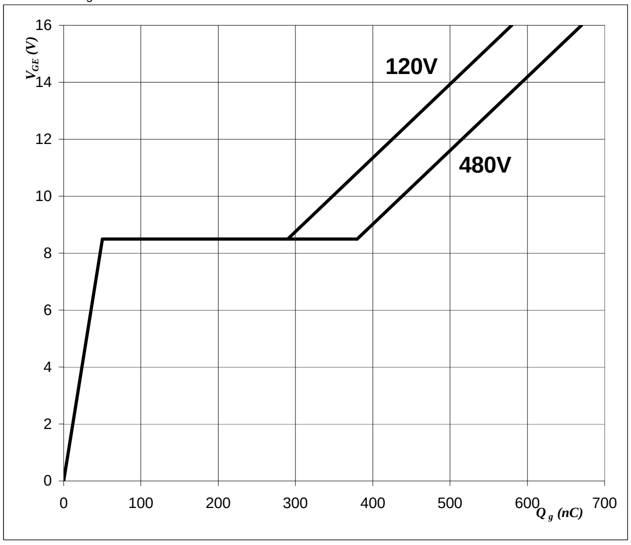
$U_{ccminus}$=U_{ccplus}

Switching mode : 3 level switching

Figure 26 NP IGBT

Gate voltage vs Gate charge

$V_{GE} = f(Q_g)$



At

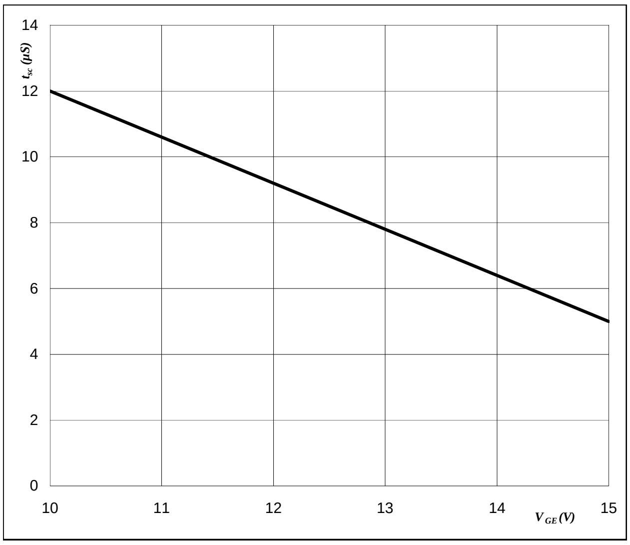
I_D = 100 A

T_j= 25 ºC

Figure 27 Output inverter IGBT

Short circuit withstand time as a function of gate-emitter voltage

$t_{sc} = f(V_{GE})$



At

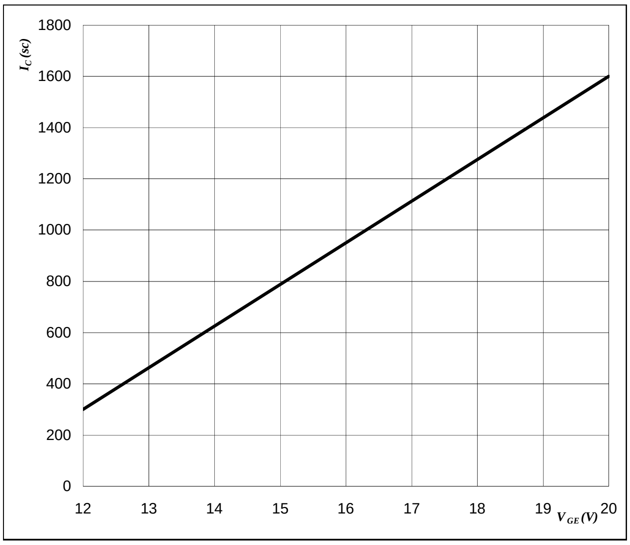
V_{CE} = 600 V

T_j ≤ 150 ºC

Figure 28 Output inverter IGBT

Typical short circuit collector current as a function of gate-emitter voltage

$V_{GE} = f(Q_{GE})$



At

V_{CE} ≤ 400 V

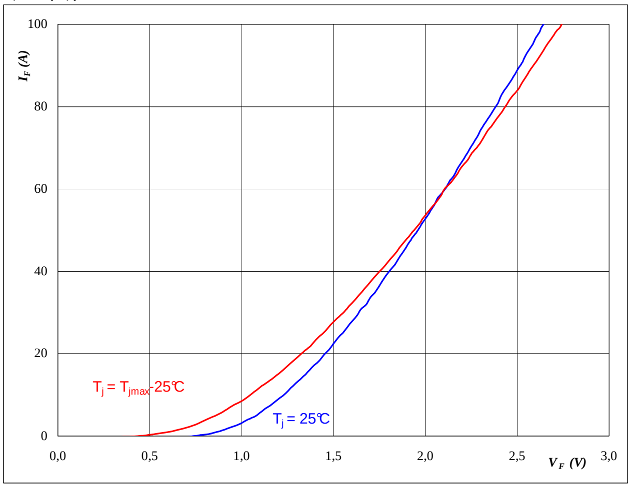
T_j = 125 ºC

NP IGBT Inverse Diode

Figure 25 NP Inverse Diode

Typical FWD forward current as a function of forward voltage

$I_F = f(V_F)$



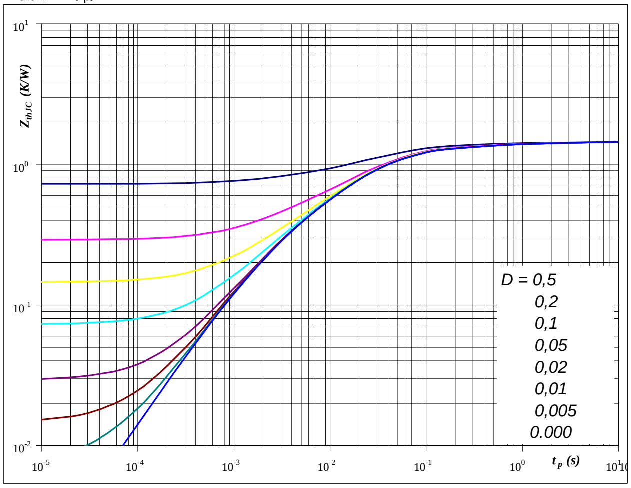
At

t_p = 250 µs

Figure 26 NP Inverse Diode

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

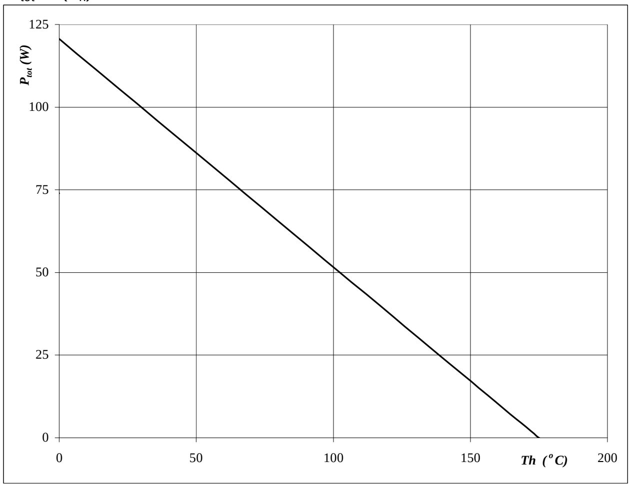
D = tp / T

R_{thJH} = 1,45 K/W

Figure 27 NP Inverse Diode

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



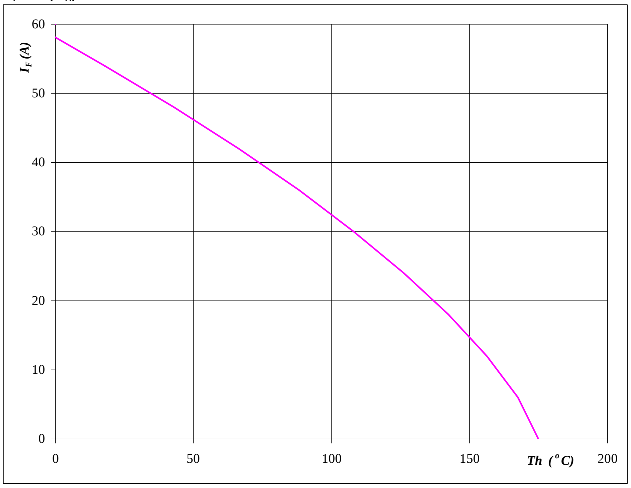
At

T_j = 175 ºC

Figure 28 NP Inverse Diode

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At

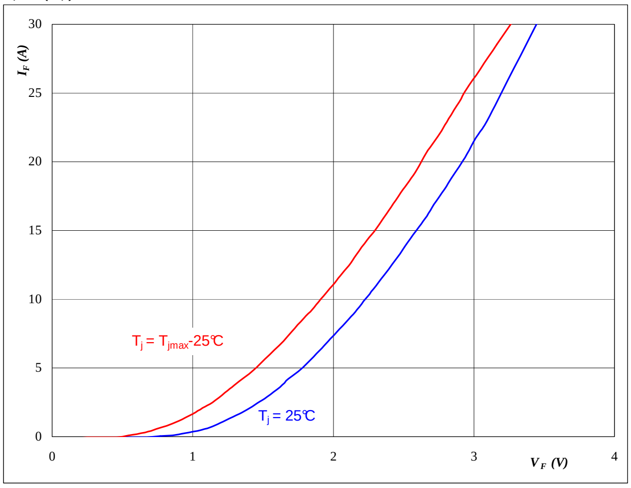
T_j = 175 ºC

Half Bridge Inverse Diode

Figure 1	Halfbridge IGBT Inverse Diode

Typical FWD forward current as a function of forward voltage

$I_F = f(V_F)$



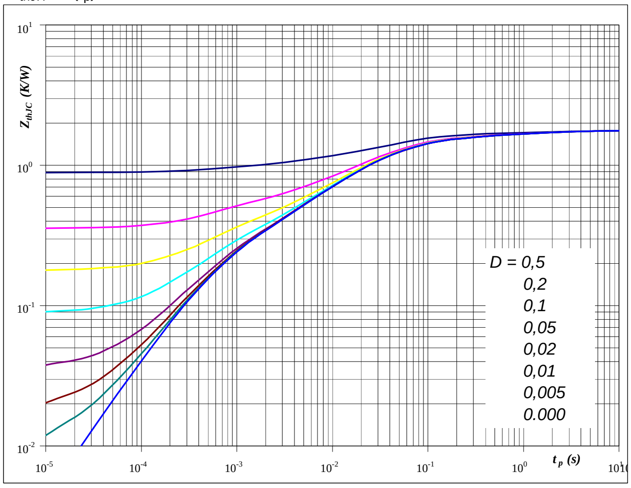
At

t_p = 250 µs

Figure 2	Halfbridge IGBT Inverse Diode

FWD transient thermal impedance as a function of pulse width

$Z_{thJH} = f(t_p)$



At

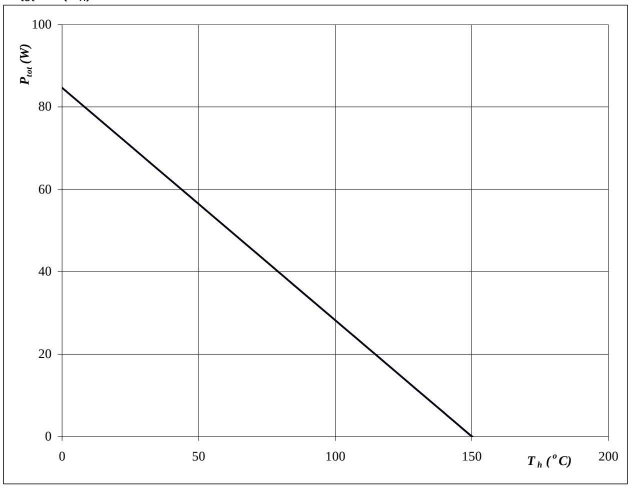
D = t_p / T

R_{thJH} = 1,77 K/W

Figure 3	Halfbridge IGBT Inverse Diode

Power dissipation as a function of heatsink temperature

$P_{tot} = f(T_h)$



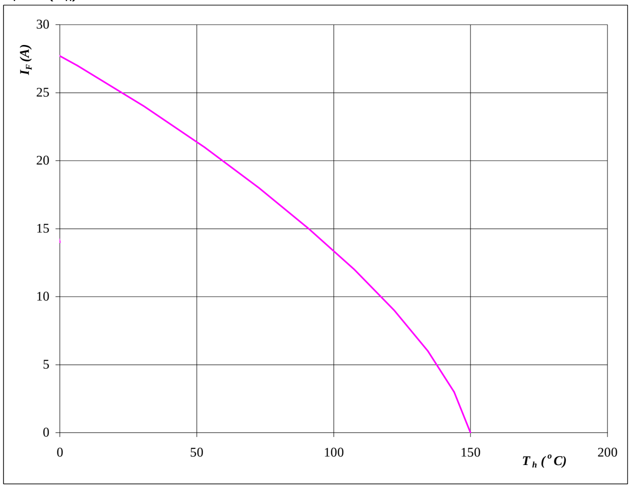
At

T_j = 150 ºC

Figure 4	Halfbridge IGBT Inverse Diode

Forward current as a function of heatsink temperature

$I_F = f(T_h)$



At

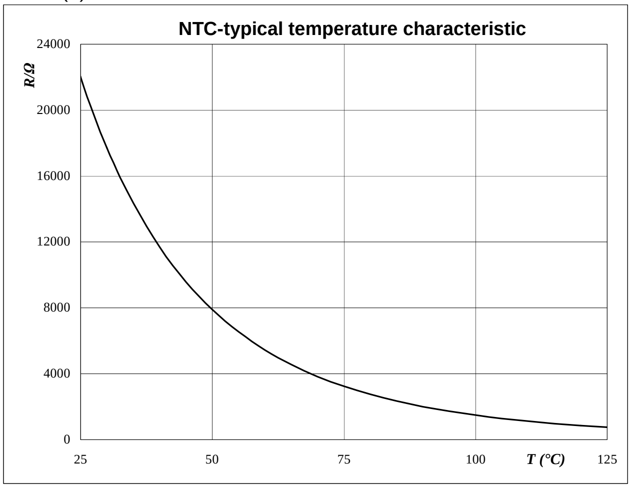
T_j = 150 ºC

Thermistor

Figure 1	Thermistor

Typical NTC characteristic
as a function of temperature

$R_T = f(T)$



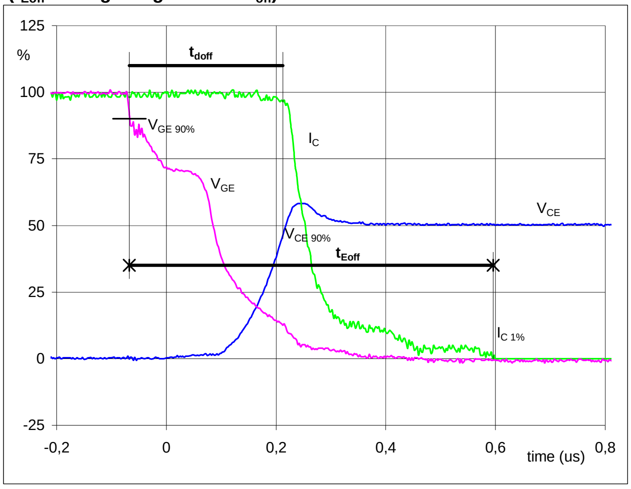
Switching Definitions Half Bridge

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

Figure 1 Half Bridge IGBT

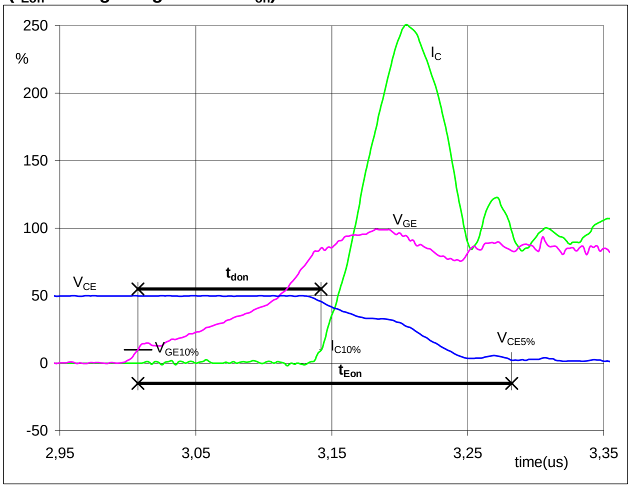
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff}
(t_{Eoff} = integrating time for E_{off})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	700	V
I_C (100%) =	100	A
t_{doff} =	0,28	µs
t_{Eoff} =	0,66	µs

Figure 2 Half Bridge IGBT

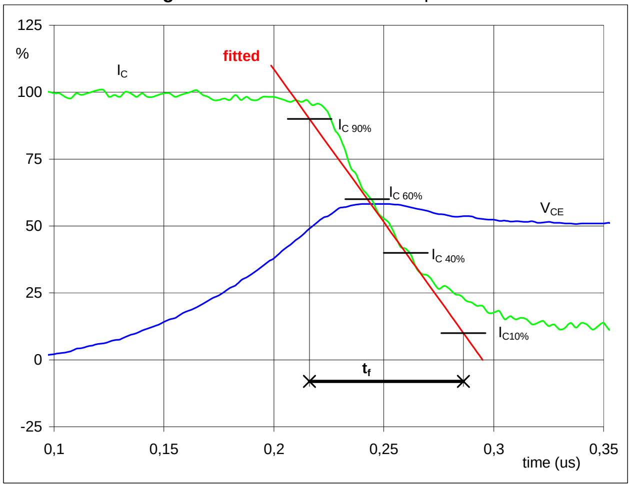
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon}
(t_{Eon} = integrating time for E_{on})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	700	V
I_C (100%) =	100	A
t_{don} =	0,14	µs
t_{Eon} =	0,27	µs

Figure 3 Half Bridge IGBT

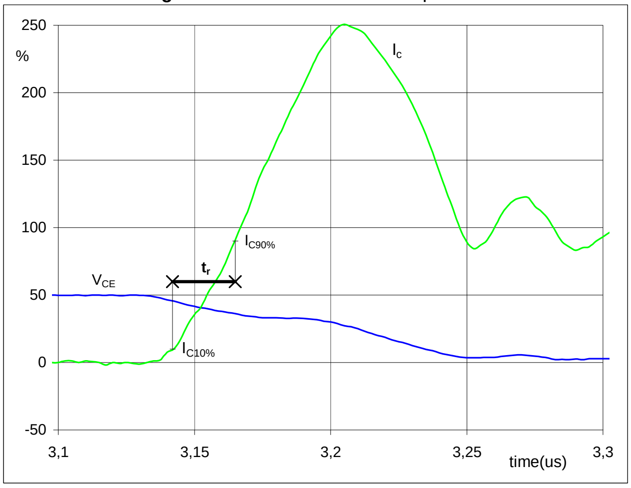
Turn-off Switching Waveforms & definition of t_f



V_C (100%) =	700	V
I_C (100%) =	100	A
t_f =	0,06	µs

Figure 4 Half Bridge IGBT

Turn-on Switching Waveforms & definition of t_r

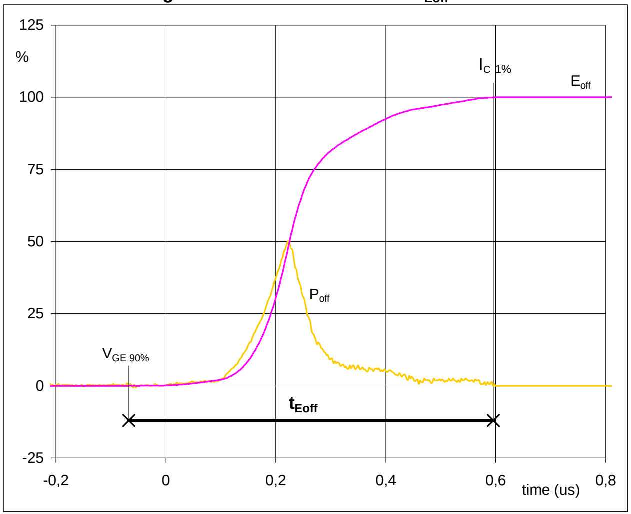


V_C (100%) =	700	V
I_C (100%) =	100	A
t_r =	0,02	µs

Switching Definitions Half Bridge

Figure 5 Half Bridge IGBT

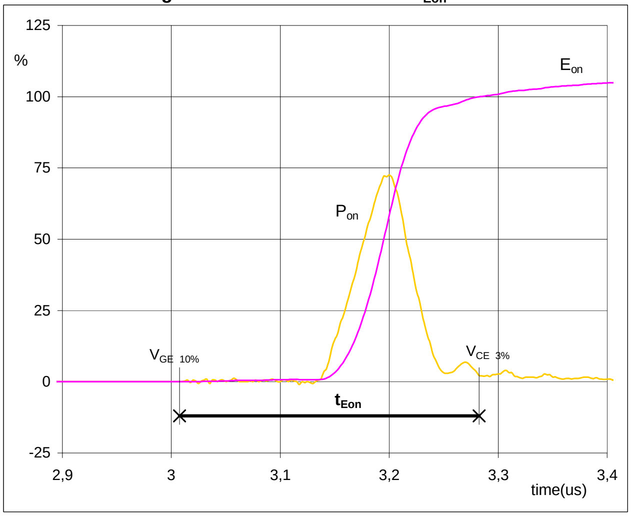
Turn-off Switching Waveforms & definition of t_{Eoff}



P_{off} (100%) =	70,22	kW
E_{off} (100%) =	4,03	mJ
t_{Eoff} =	0,66	μs

Figure 6 Half Bridge IGBT

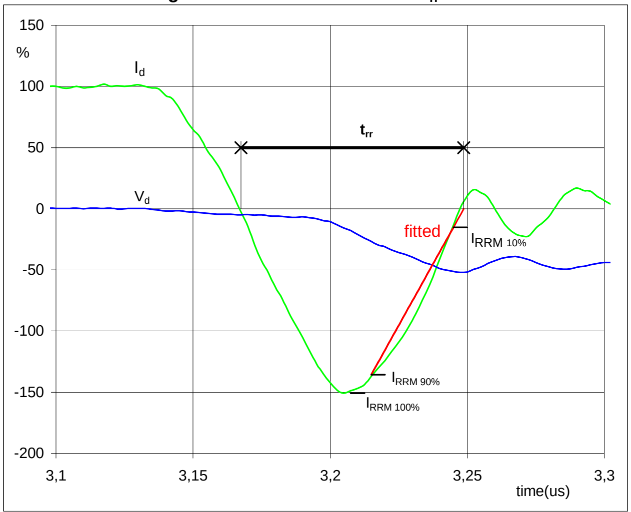
Turn-on Switching Waveforms & definition of t_{Eon}



P_{on} (100%) =	70,22	kW
E_{on} (100%) =	3,18	mJ
t_{Eon} =	0,27	μs

Figure 7 Neutral Point FWD

Turn-off Switching Waveforms & definition of t_{rr}

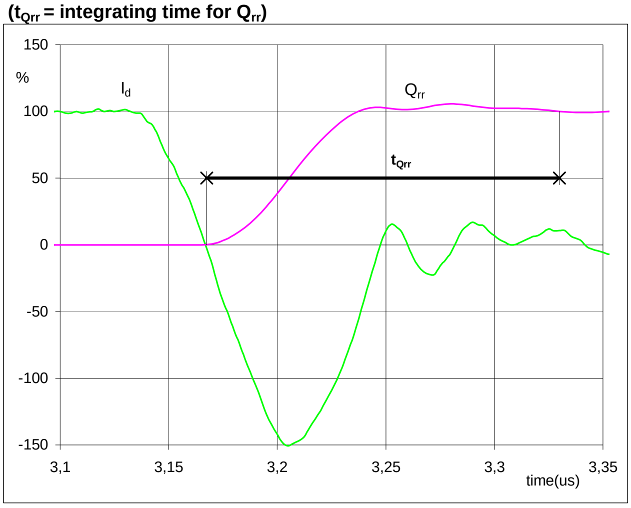


V_d (100%) =	700	V
I_d (100%) =	100	A
I_{RRM} (100%) =	-151	A
t_{rr} =	0,08	μs

Switching Definitions Half Bridge

Figure 8 Neutral Point FWD

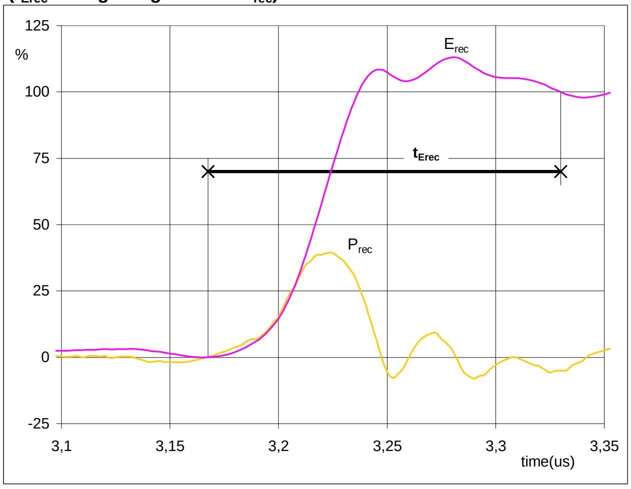
Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})



I_d (100%) =	100	A
Q_{rr} (100%) =	7,13	µC
t_{Qrr} =	0,16	µs

Figure 9 Neutral Point FWD

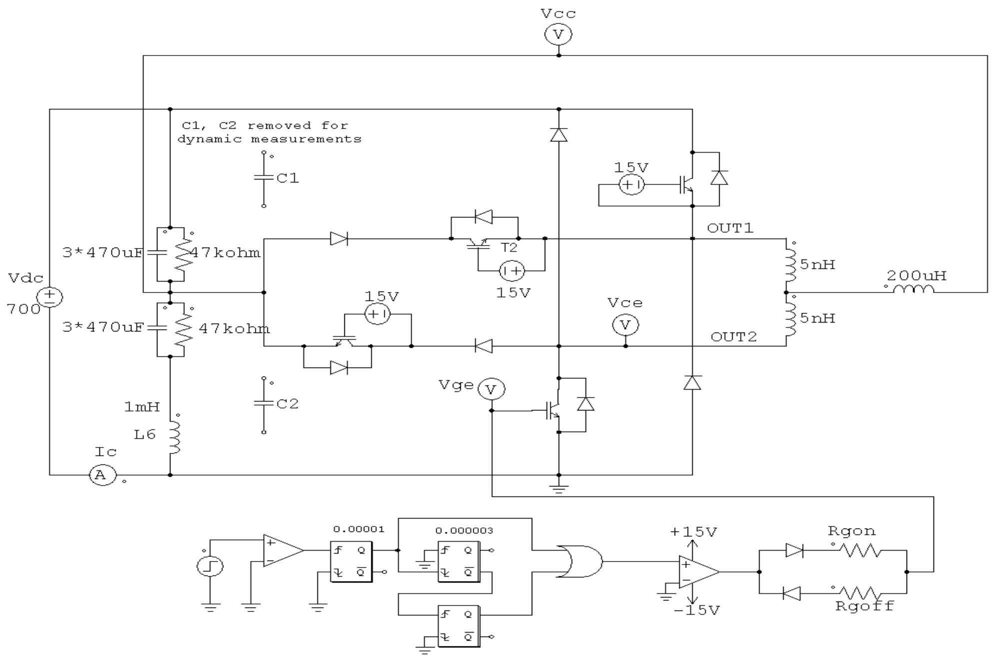
Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec}= integrating time for E_{rec})



P_{rec} (100%) =	70,22	kW
E_{rec} (100%) =	1,01	mJ
t_{Erec} =	0,16	µs

half bridge switching measurement circuit

Figure 10 Half Bridge IGBT



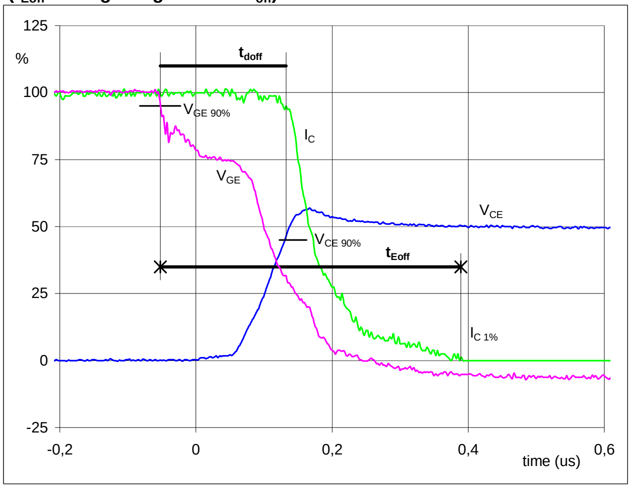
Switching Definitions Neutral Point IGBT

General conditions

T_j	=	125 °C
R_{gon}	=	4 Ω
R_{goff}	=	4 Ω

Figure 1 neutral point IGBT

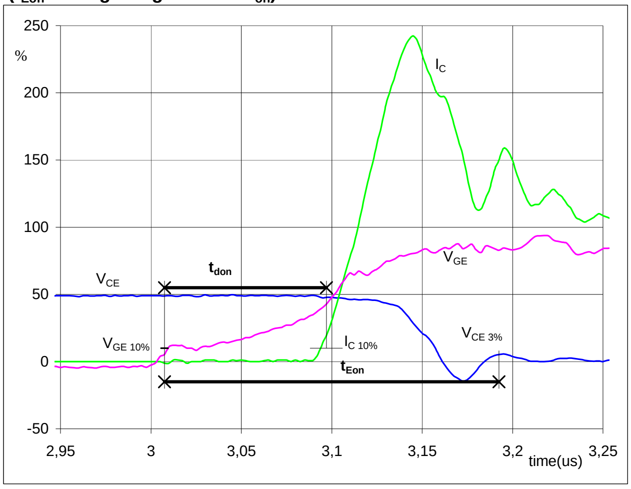
Turn-off Switching Waveforms & definition of t_{doff}, t_{Eoff}
(t_{Eoff} = integrating time for E_{off})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	700	V
I_C (100%) =	100	A
t_{doff} =	0,18	μs
t_{Eoff} =	0,44	μs

Figure 2 neutral point IGBT

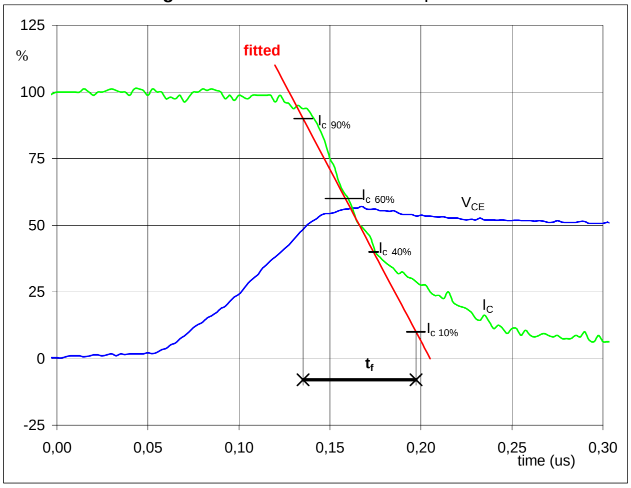
Turn-on Switching Waveforms & definition of t_{don}, t_{Eon}
(t_{Eon} = integrating time for E_{on})



V_{GE} (0%) =	-15	V
V_{GE} (100%) =	15	V
V_C (100%) =	700	V
I_C (100%) =	100	A
t_{don} =	0,10	μs
t_{Eon} =	0,18	μs

Figure 3 neutral point IGBT

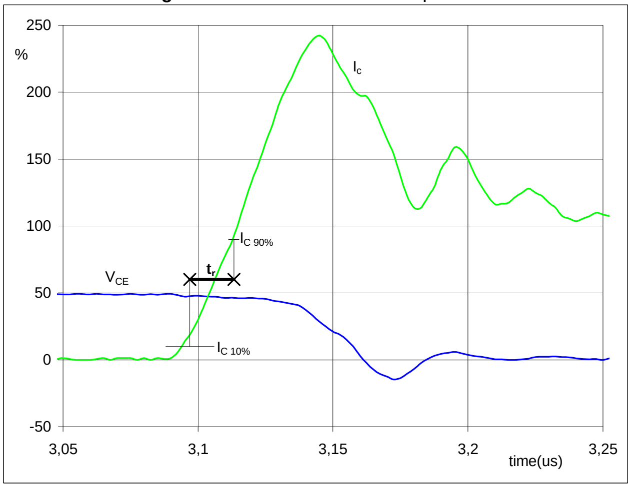
Turn-off Switching Waveforms & definition of t_f



V_C (100%) =	700	V
I_C (100%) =	100	A
t_f =	0,064	μs

Figure 4 neutral point IGBT

Turn-on Switching Waveforms & definition of t_r

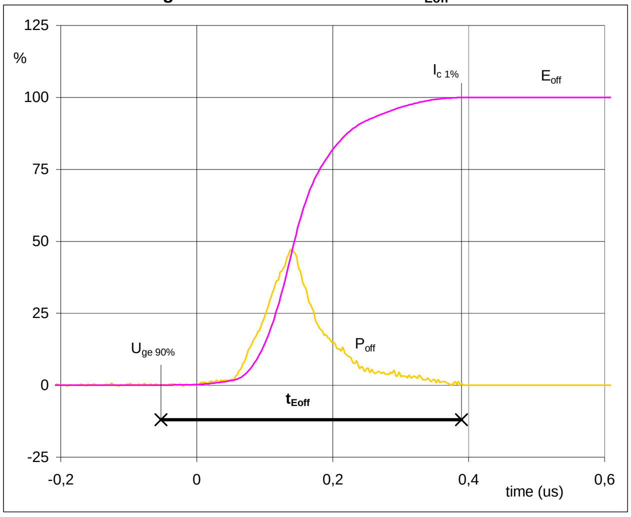


V_C (100%) =	700	V
I_C (100%) =	100	A
t_r =	0,019	μs

Switching Definitions Neutral Point IGBT

Figure 5 neutral point IGBT

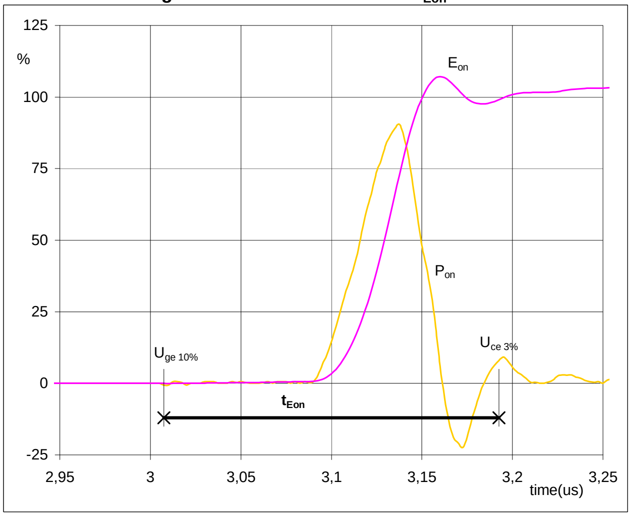
Turn-off Switching Waveforms & definition of t_{Eoff}



P_{off} (100%) =	69,93	kW
E_{off} (100%) =	3,32	mJ
t_{Eoff} =	0,44	μs

Figure 6 neutral point IGBT

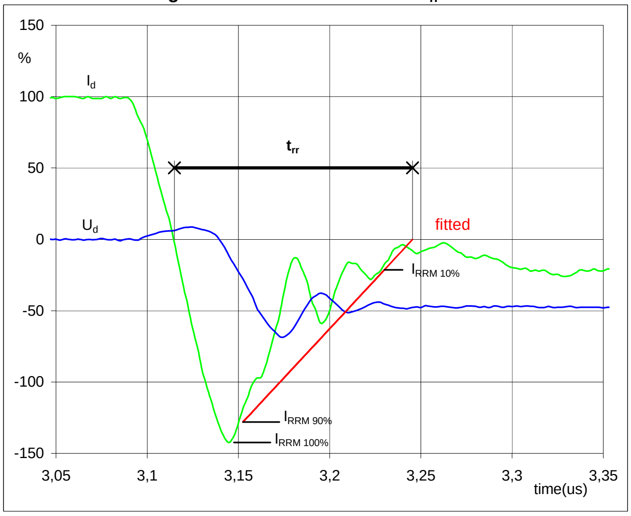
Turn-on Switching Waveforms & definition of t_{Eon}



P_{on} (100%) =	69,9279	kW
E_{on} (100%) =	1,52	mJ
t_{Eon} =	0,18	μs

Figure 7 half bridge FWD

Turn-off Switching Waveforms & definition of t_{rr}

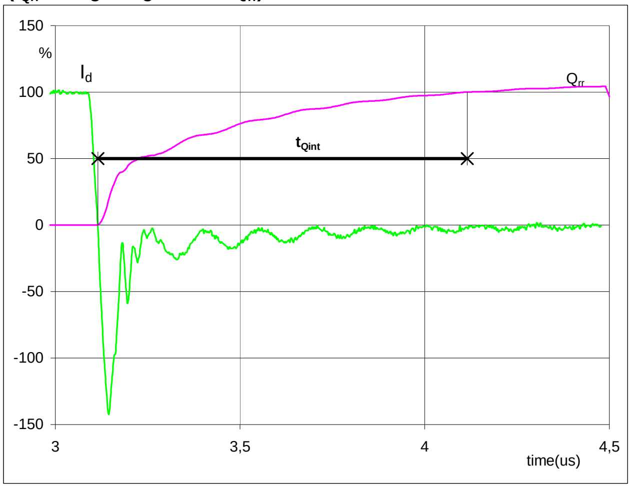


V_d (100%) =	700	V
I_d (100%) =	100	A
I_{RRM} (100%) =	-142	A
t_{rr} =	0,07	μs

Switching Definitions Neutral Point IGBT

Figure 8 half bridge FWD

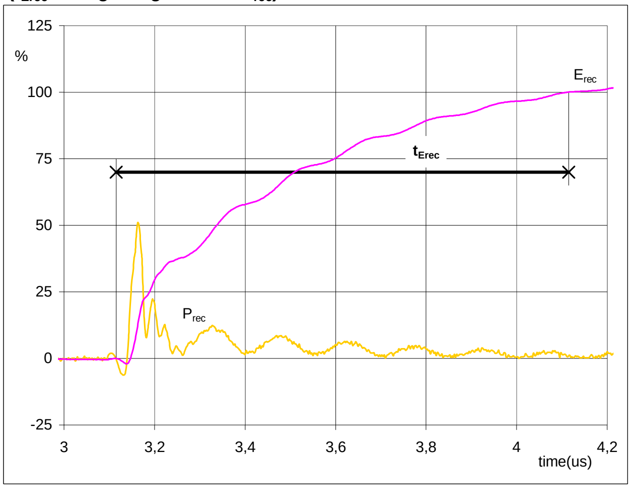
Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr}= integrating time for Q_{rr})



I_d (100%) =	100	A
Q_{rr} (100%) =	12,71	μC
t_{Qint} =	1,00	μs

Figure 9 half bridge FWD

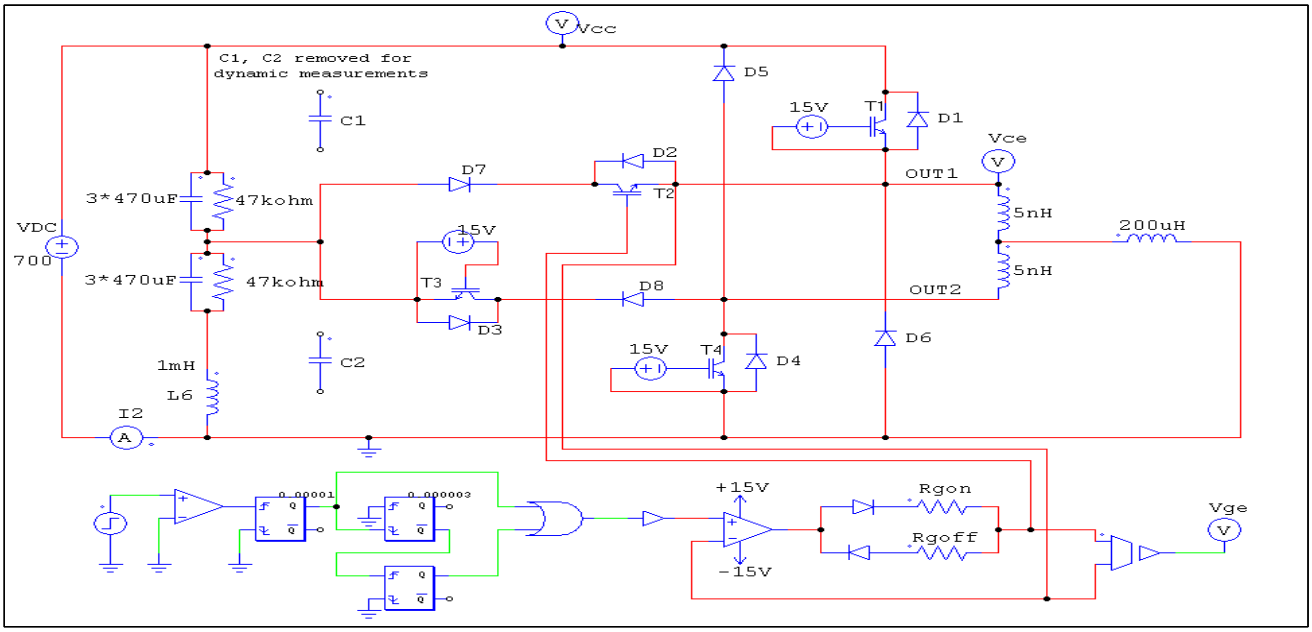
Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec}= integrating time for E_{rec})



P_{rec} (100%) =	69,93	kW
E_{rec} (100%) =	3,61	mJ
t_{Erec} =	1,00	μs

Neutral Point IGBT switching measurement circuit

Figure 10 neutral point IGBT



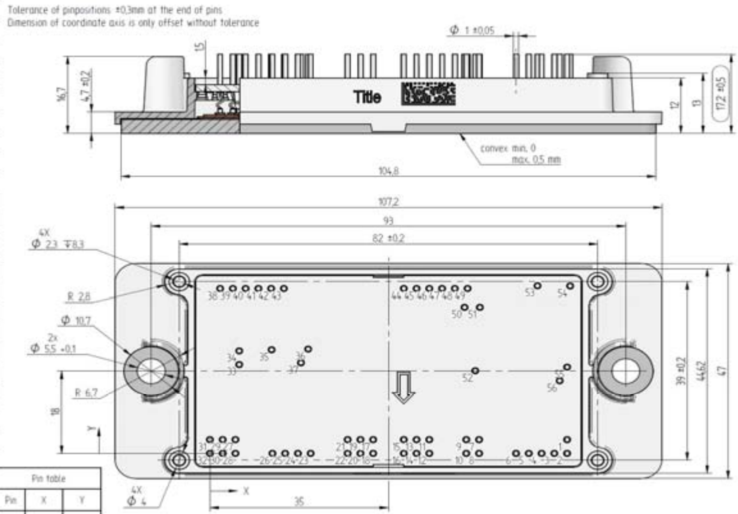
Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking

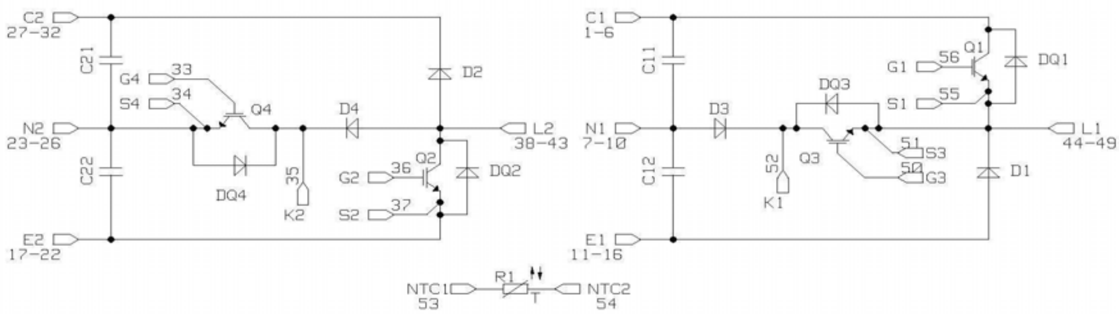
Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 13mm housing	30-FT12NMA160SH-M669F08	M669F08	M669F08

Outline

Pin table			Pin table			Pin table		
Pin	X	Y	Pin	X	Y	Pin	X	Y
1	70	3	27	5	3			
2	70	0	28	5	0			
3	67,5	0	29	2,5	3			
4	65	0	30	2,5	0			
5	62,5	0	31	0	3			
6	60	0	32	0	0			
7	52,75	3	33	5,75	19,45			
8	52,75	0	34	5,75	22,45			
9	50,25	3	35	12,1	22,7			
10	50,25	0	36	19,25	22,85			
11	43	3	37	17,85	19,85			
12	43	0	38	2	36			
13	40,5	3	39	4,5	36			
14	40,5	0	40	7	36			
15	38	3	41	9,5	36			
16	38	0	42	12	36			
17	32	3	43	14,5	36			
18	32	0	44	38	36			
19	29,5	3	45	40,5	36			
20	29,5	0	46	43	36			
21	27	3	47	45,5	36			
22	27	0	48	48	36			
23	19,75	0	49	50,5	36	53	64,2	36,6
24	17,25	0	50	49,9	32	54	70,6	36,55
25	14,75	0	51	52,9	32	55	70	18,9
26	12,25	0	52	52	18,1	56	68,55	15,9



Pinout



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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.